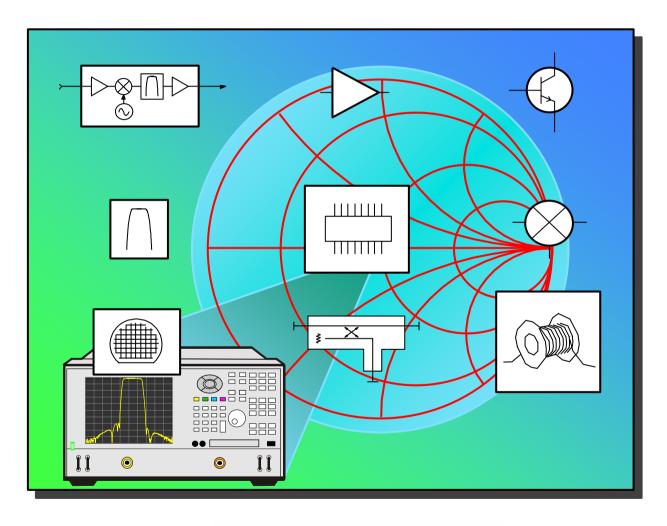
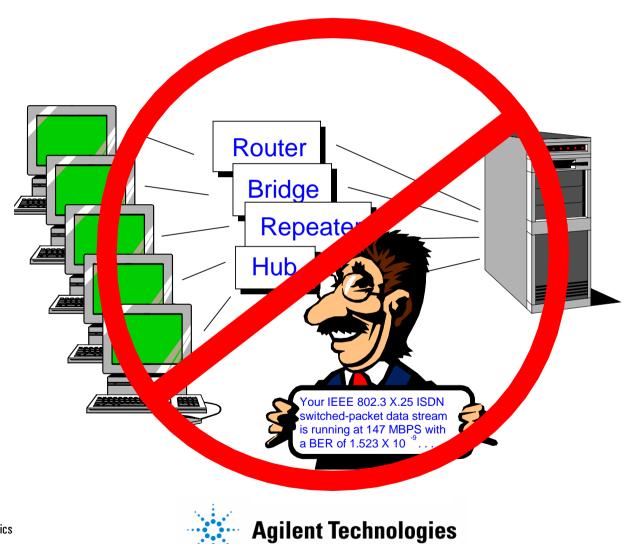
# **Network Analyzer Basics**





# **Network Analysis is NOT....**

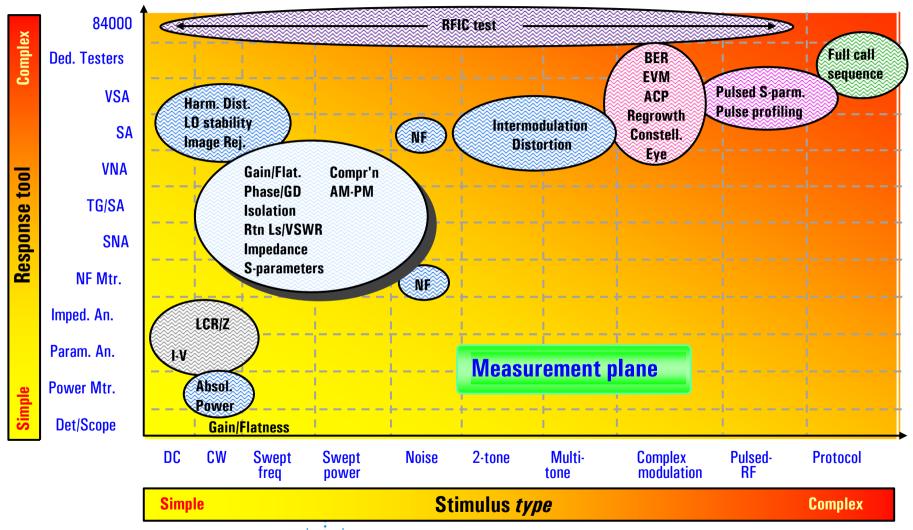


# What Types of Devices are Tested?

High **Duplexers RFICs Diplexers MMICs Filters** TIR modules **Transceivers Couplers Bridges** Splitters, dividers Receivers **Combiners** Tuners Isolators Converters **Circulators VCAs Attenuators Integration Adapters Amplifiers Antennas** Opens, shorts, loads **Delay lines VCOs Switches Cables VTFs Transmission lines Multiplexers Oscillators Mixers** Waveguide Modulators **Samplers Resonators VCAtten's Multipliers Dielectrics Diodes** R, L, C's **Transistors Device type Passive Active** 

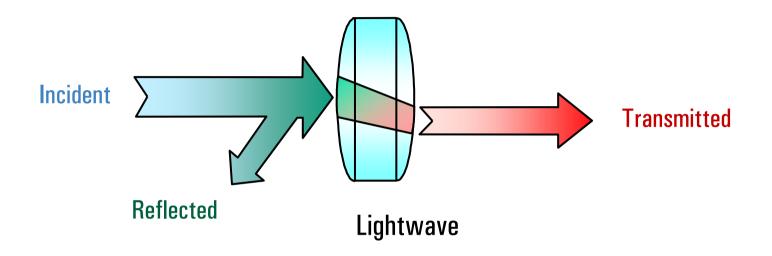


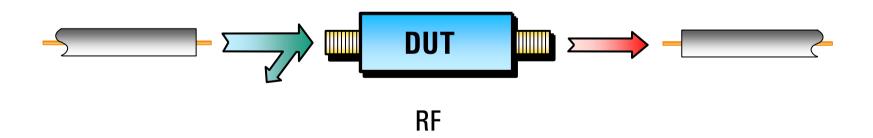
#### **Device Test Measurement Model**





# Lightwave Analogy to RF Energy





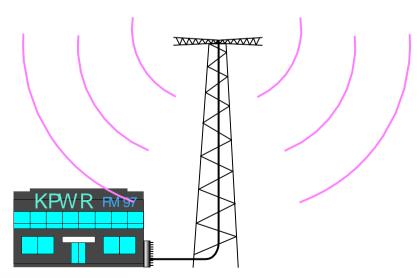


# Why Do We Need to Test Components?

- Verify specifications of "building blocks" for more complex RF systems
- Ensure distortionless transmission of communications signals



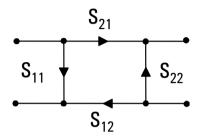
- linear: constant amplitude, linear phase / constant group delay
- nonlinear: harmonics, intermodulation, compression, AM-to-PM conversion
- Ensure good match when absorbing power (e.g., an antenna)





## The Need for Both Magnitude and Phase

1. Complete characterization of linear networks



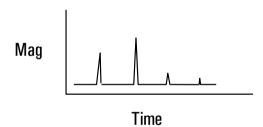
2. Complex impedance needed to design matching circuits



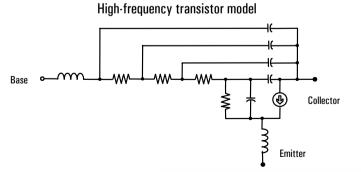
3. Complex values needed for device modeling

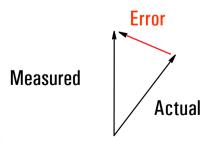


4. Time-domain characterization



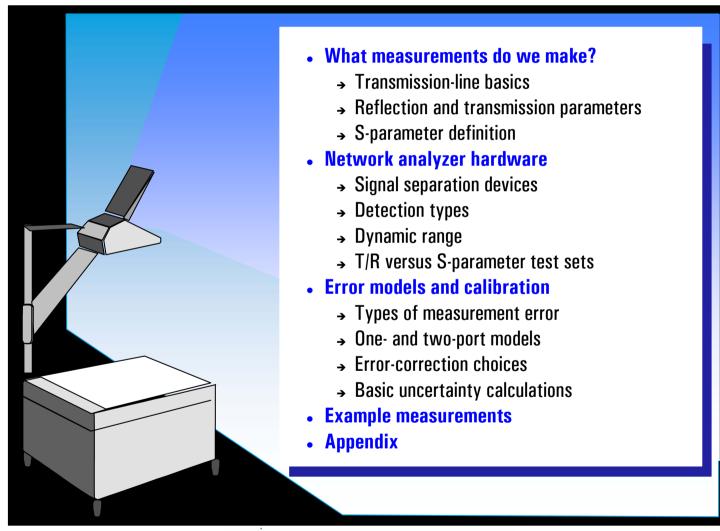
5. Vector-error correction







#### Agenda



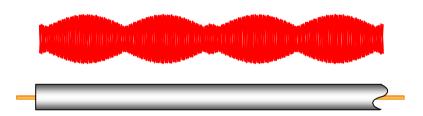


#### **Transmission Line Basics**



#### Low frequencies

- wavelengths >> wire length
- current (I) travels down wires easily for efficient power transmission
- measured voltage and current not dependent on position along wire



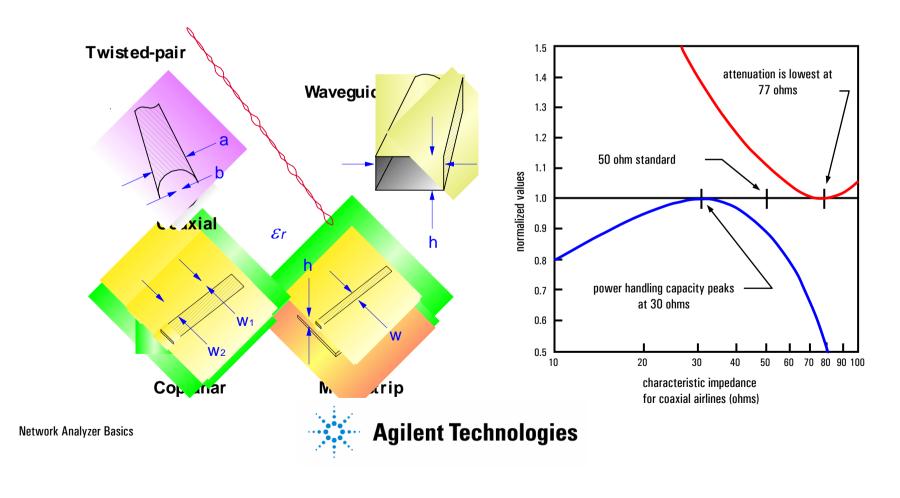
#### High frequencies

- wavelength  $\approx$  or << length of transmission medium
- need transmission lines for efficient power transmission
- matching to characteristic impedance (Z<sub>0</sub>) is very important for low reflection and maximum power transfer
- measured envelope voltage dependent on position along line

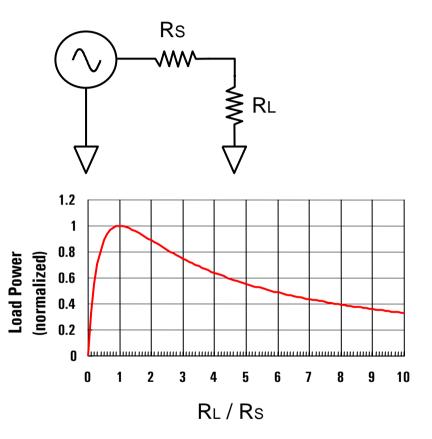


#### Transmission line Zo

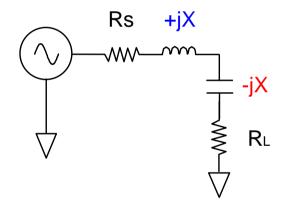
- Zo determines relationship between voltage and current waves
- Zo is a function of physical dimensions and  $\mathcal{E}_r$
- Zo is usually a real impedance (e.g. 50 or 75 ohms)



## **Power Transfer Efficiency**



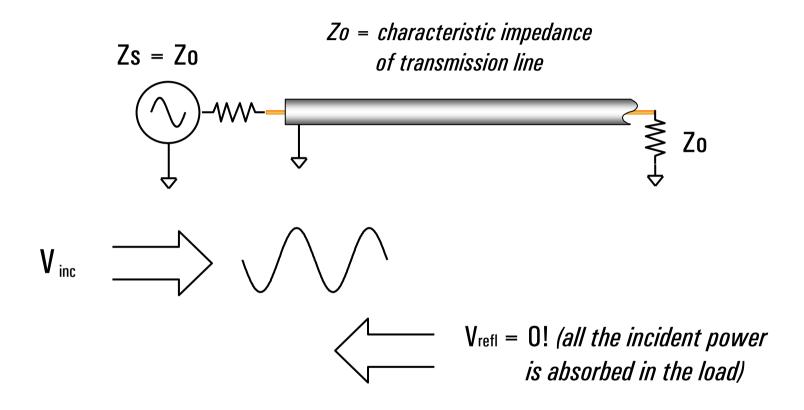
For complex impedances, maximum power transfer occurs when  $Z_L = Z_S^*$  (conjugate match)



Maximum power is transferred when RL = RS



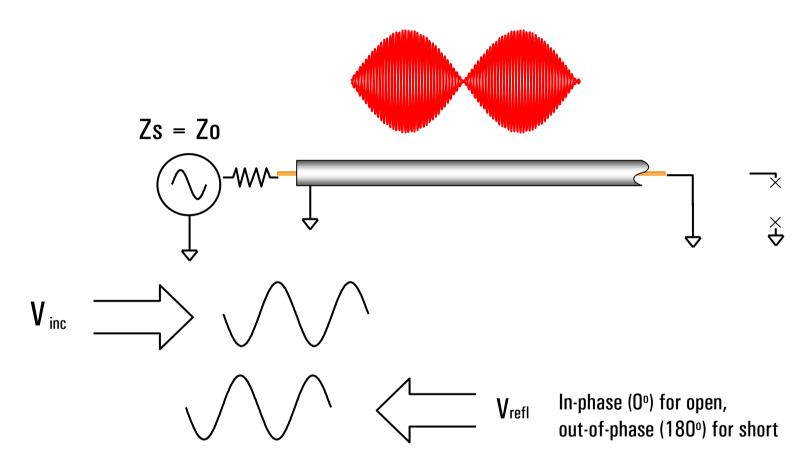
#### Transmission Line Terminated with Zo



For reflection, a transmission line terminated in Zo behaves like an infinitely long transmission line



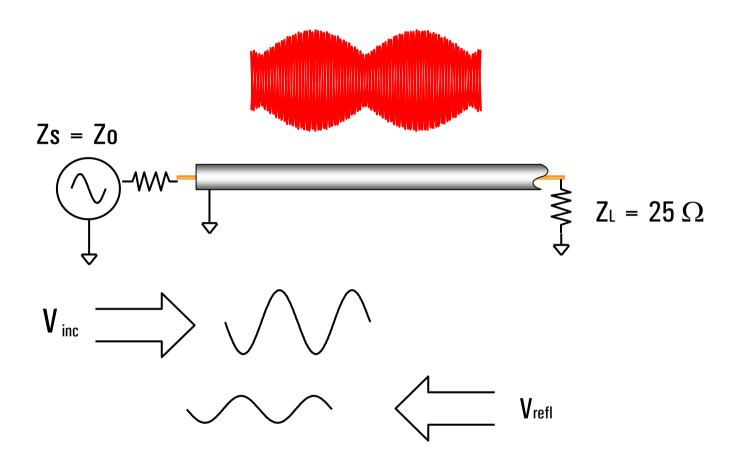
# Transmission Line Terminated with Short, Open



For reflection, a transmission line terminated in a short or open reflects all power back to source



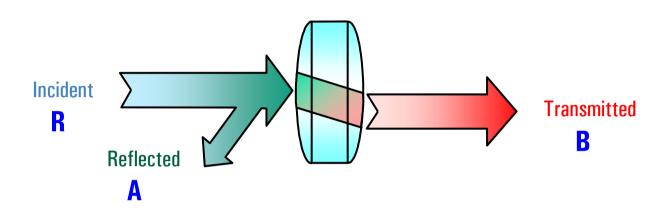
#### Transmission Line Terminated with 25 $\Omega$



Standing wave pattern does not go to zero as with short or open



# **High-Frequency Device Characterization**



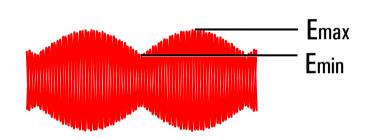
#### **TRANSMISSION** REFLECTION **Transmitted** Reflected Incident R Incident Group Return **SWR** Gain / Loss Delay Loss Insertion **S-Parameters** Impedance, **S-Parameters** $S_{11}, S_{22}$ Reflection Phase **Admittance Transmission** S<sub>21</sub>, S<sub>12</sub> Coefficient R+jX, Coefficient G+jB $\Gamma, \rho$ $T, \tau$ **Agilent Technologies Network Analyzer Basics**

#### **Reflection Parameters**

$$\Gamma = \frac{V_{\text{reflected}}}{V_{\text{incident}}} = \rho \angle \Phi = \frac{Z_L - Z_0}{Z_L + Z_0}$$

**Return loss** = 
$$-20 \log(\rho)$$
,

$$\rho$$
 =  $|\Gamma|$ 



#### **Voltage Standing Wave Ratio**

$$VSWR = \frac{E_{max}}{E_{min}} = \frac{1 + \rho}{1 \cdot \rho}$$

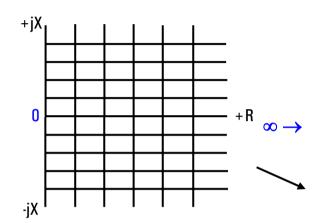
#### No reflection

$$(Z\iota = Zo)$$

Full reflection (Z<sub>L</sub> = open, short)

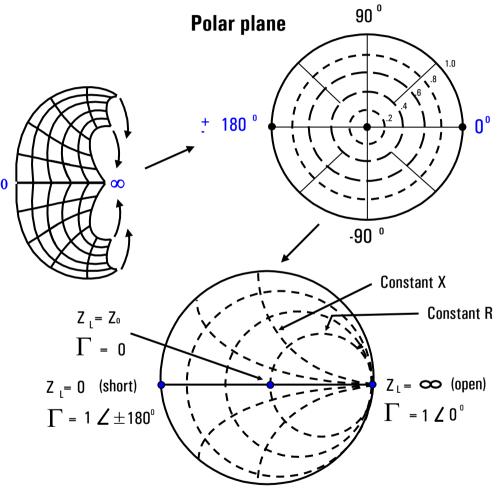


#### **Smith Chart Review**



Rectilinear impedance plane

Smith Chart maps rectilinear impedance plane onto polar plane







#### **Transmission Parameters**



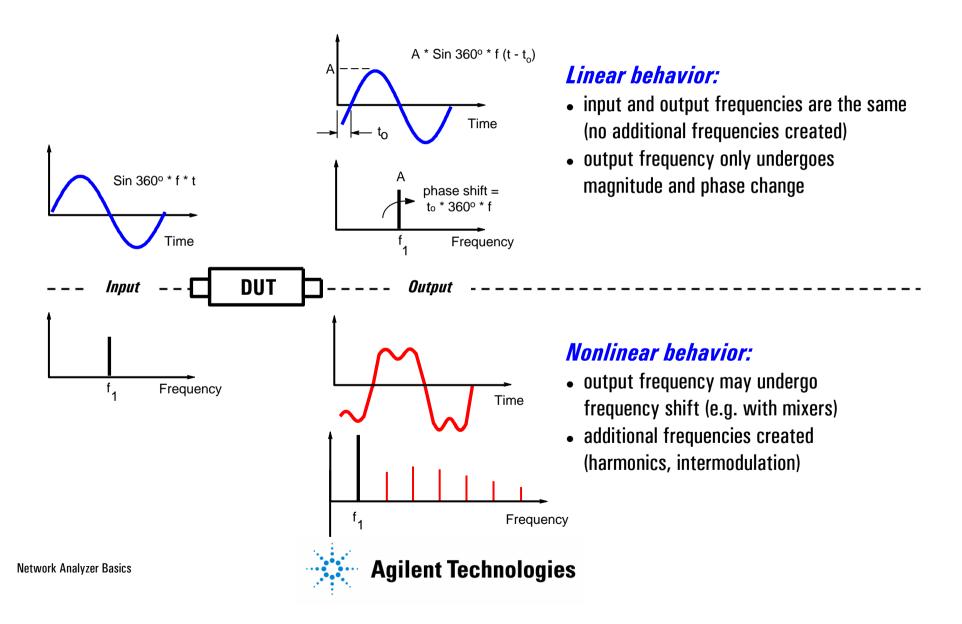
Transmission Coefficient = 
$$T = \frac{V_{Transmitted}}{V_{Incident}} = \tau \angle \phi$$

Insertion Loss (dB) = 
$$-20 \text{ Log}$$
  $\left| \begin{array}{c} V \\ \hline V \\ \\ \end{array} \right|$  Inc  $\left| \begin{array}{c} -20 \log \mathcal{T} \\ \end{array} \right|$ 

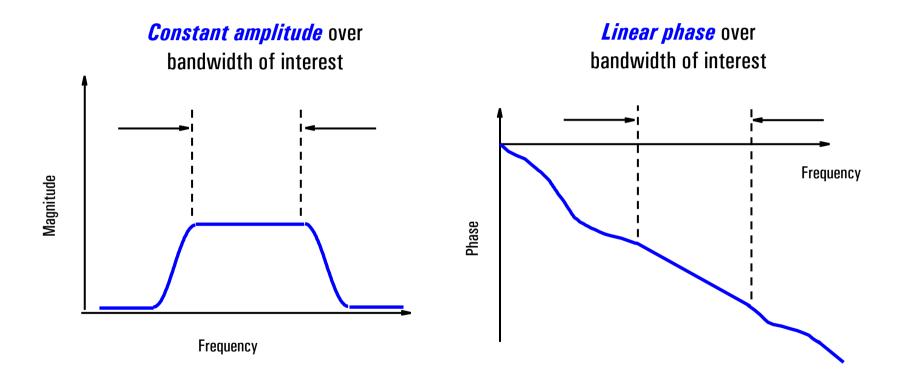
Gain (dB) = 20 Log 
$$\left| \begin{array}{c} V \\ \hline V \\ Inc \end{array} \right|$$
 = 20 log  $\mathcal{T}$ 



#### **Linear Versus Nonlinear Behavior**



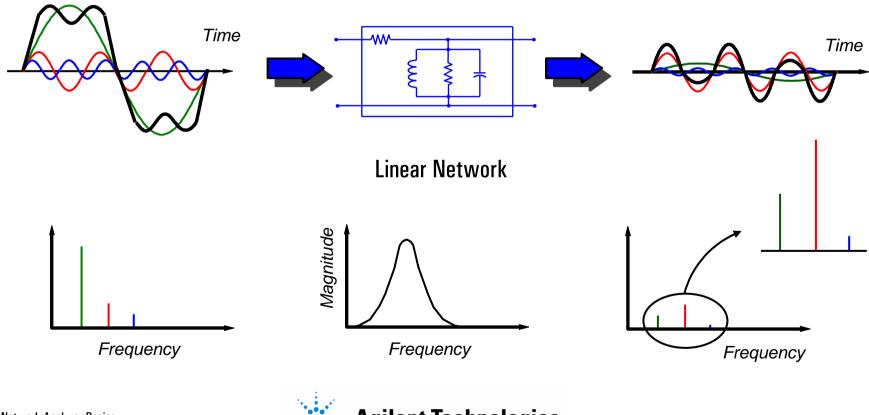
# Criteria for Distortionless Transmission *Linear Networks*





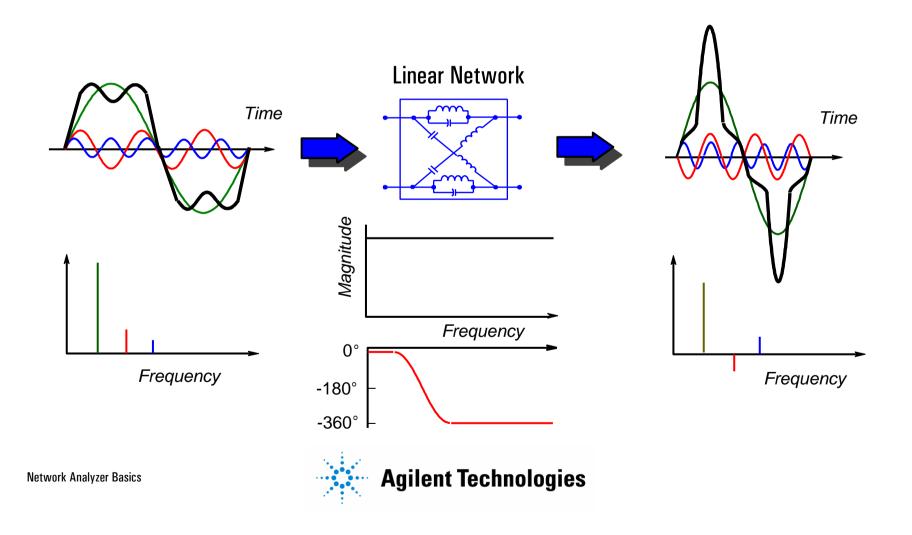
# Magnitude Variation with Frequency

 $F(t) = \sin wt + \frac{1}{3} \sin \frac{3}{4}wt + \frac{1}{5} \sin \frac{5}{4}wt$ 



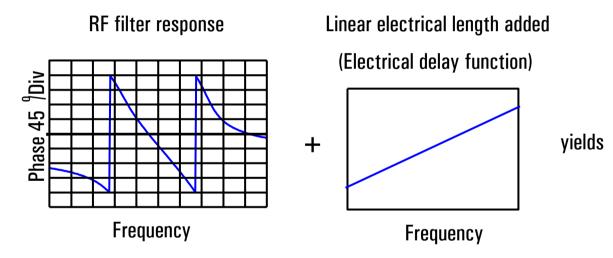
# Phase Variation with Frequency

$$F(t) = \sin wt + \frac{1}{3} \sin \frac{3}{4}wt + \frac{1}{5} \sin \frac{5}{4}wt$$



#### **Deviation from Linear Phase**

# Use electrical delay to remove linear portion of phase response



Deviation from linear phase

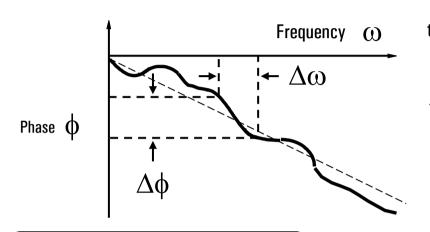
No. of the second seco

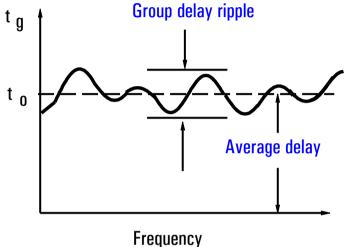
Low resolution

**High resolution** 



# **Group Delay**





Group Delay (t ) 
$$g = \frac{-d \phi}{d \omega} = \frac{-1}{360^{-0}} * \frac{d \phi}{d f}$$

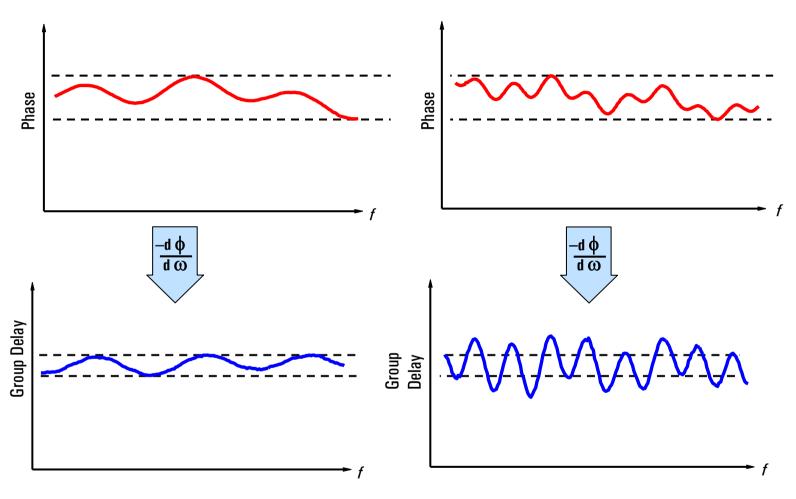
- h in radians
- (n) in radians/sec
- in degrees

f in Hertz ( $\omega = 2 \pi f$ )

- group-delay ripple indicates phase distortion
- average delay indicates electrical length of DUT
- aperture of measurement is very important



# Why Measure Group Delay?



Same p-p phase ripple can result in different group delay



## **Characterizing Unknown Devices**

#### Using parameters (H, Y, Z, S) to characterize devices:

- gives linear behavioral model of our device
- measure parameters (e.g. voltage and current) versus frequency under various source and load conditions (e.g. short and open circuits)
- compute device parameters from measured data
- predict circuit performance under any source and load conditions

$$I_2 = h_{21}I_1 + h_{22}V_2$$
  $I_2 = y_{21}V_1 + y_{22}V_2$   $V_2 = z_{21}I_1 + z_{22}I_2$ 

$$I_1 = y_{11}V_1 + y_{12}V_2$$

$$I_2 = y_{21}V_1 + y_{22}V_2$$

$$V_1 = Z_{11}I_1 + Z_{12}I_2$$

$$V_2 = Z_{21}I_1 + Z_{22}I_2$$



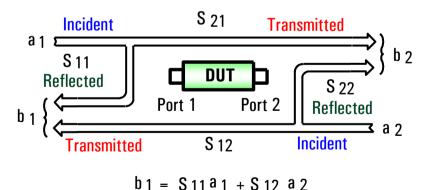
$$h_{11} = \frac{V_1}{I_1} \Big|_{V_2=0} \quad (requires short circuit)$$

$$h_{12} = \frac{V_1}{V_2} \Big|_{I_1=0}$$
 (requires open circuit



# Why Use S-Parameters?

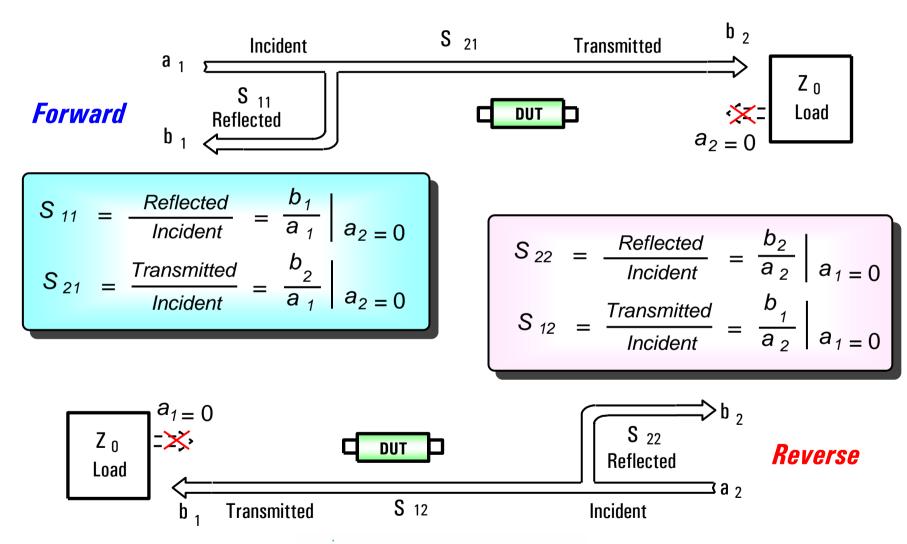
- relatively easy to obtain at high frequencies
  - measure voltage traveling waves with a vector network analyzer
  - don't need shorts/opens which can cause active devices to oscillate or self-destruct
- relate to **familiar** measurements (gain, loss, reflection coefficient ...)
- can **cascade** S-parameters of multiple devices to predict system performance
- can compute H, Y, or Z parameters from S-parameters if desired
- can easily import and use S-parameter files in our **electronic-simulation** tools



$$b = S21 a_1 + S22 a_2$$



## **Measuring S-Parameters**



## **Equating S-Parameters with Common Measurement Terms**

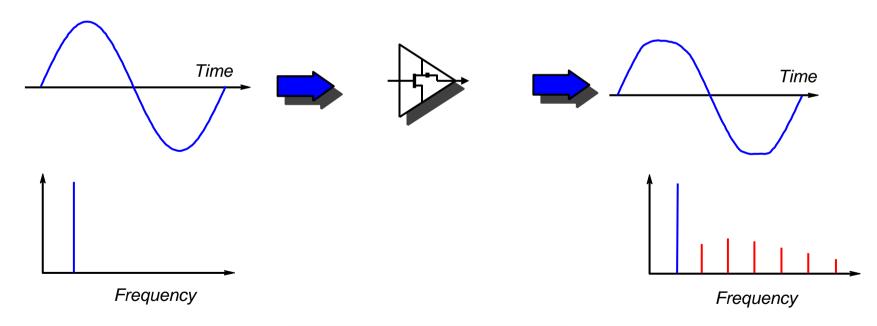
- S11 = forward reflection coefficient (input match)
- S22 = reverse reflection coefficient (output match)
- S21 = forward transmission coefficient *(gain or loss)*
- S12 = reverse transmission coefficient (isolation)

Remember, S-parameters are inherently complex, linear quantities -- however, we often express them in a log-magnitude format



# Criteria for Distortionless Transmission Nonlinear Networks

- Saturation, crossover, intermodulation, and other nonlinear effects can cause signal distortion
- Effect on system depends on amount and type of distortion and system architecture

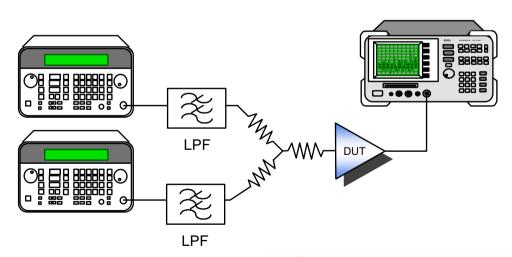


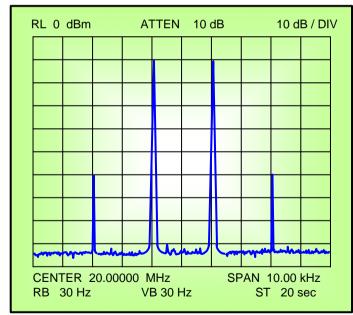


# **Measuring Nonlinear Behavior**

#### Most common measurements:

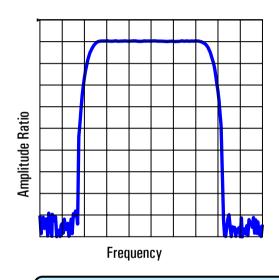
- using a *network analyzer* and power sweeps
  - → gain compression
  - → AM to PM conversion
- using a **spectrum analyzer** + source(s)
  - → harmonics, particularly second and third
  - → intermodulation products resulting from two or more RF carriers

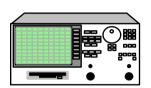




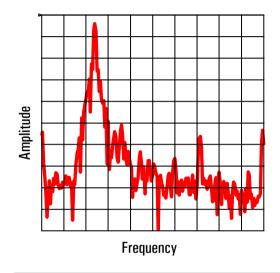


# What is the Difference Between Network and Spectrum Analyzers?





Measures known signal





Measures unknown signals

#### **Network analyzers:**

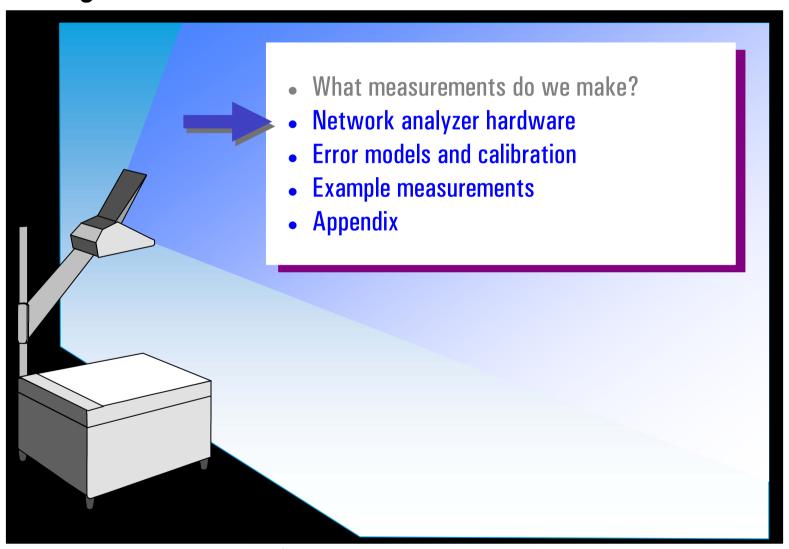
- measure components, devices, circuits, sub-assemblies
- contain source and receiver
- display ratioed amplitude and phase (frequency or power sweeps)
- offer advanced error correction

#### **Spectrum analyzers:**

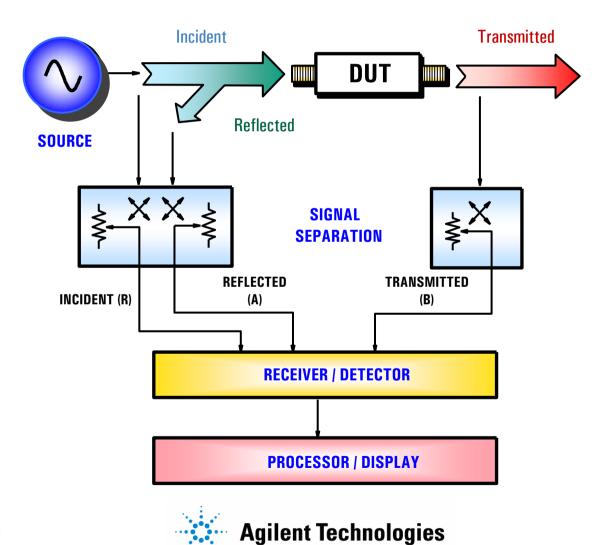
- measure signal amplitude characteristics carrier level, sidebands, harmonics...)
- can demodulate (& measure) complex signals
- are receivers only (single channel)
- can be used for scalar component test (no phase) with tracking gen. or ext. source(s)



# Agenda



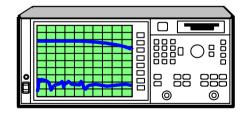
# Generalized Network Analyzer Block Diagram

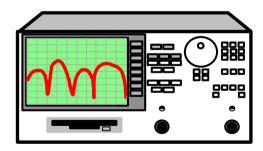


#### Source

- Supplies stimulus for system
- Swept frequency or power
- Traditionally NAs used separate source
- Most Agilent analyzers sold today have integrated, synthesized sources

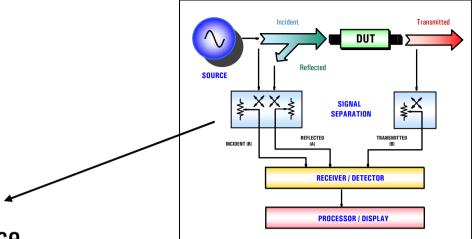




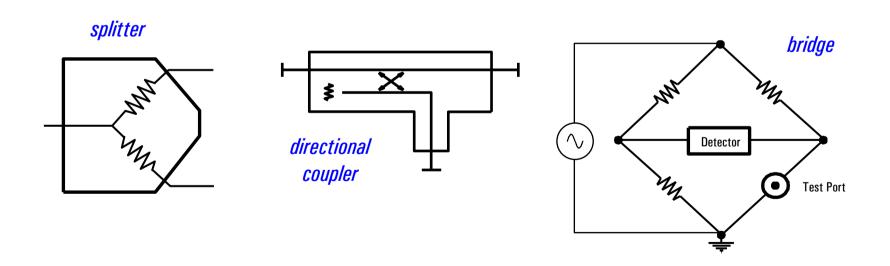








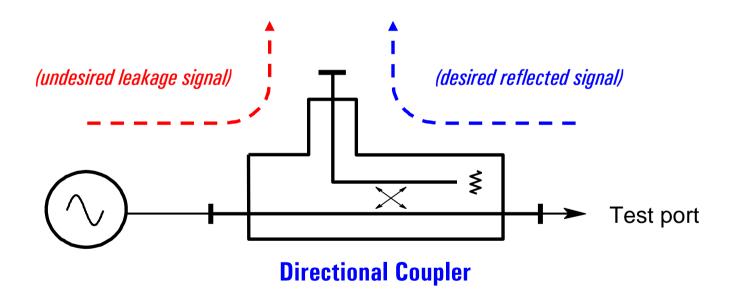
- measure incident signal for reference
- separate incident and reflected signals



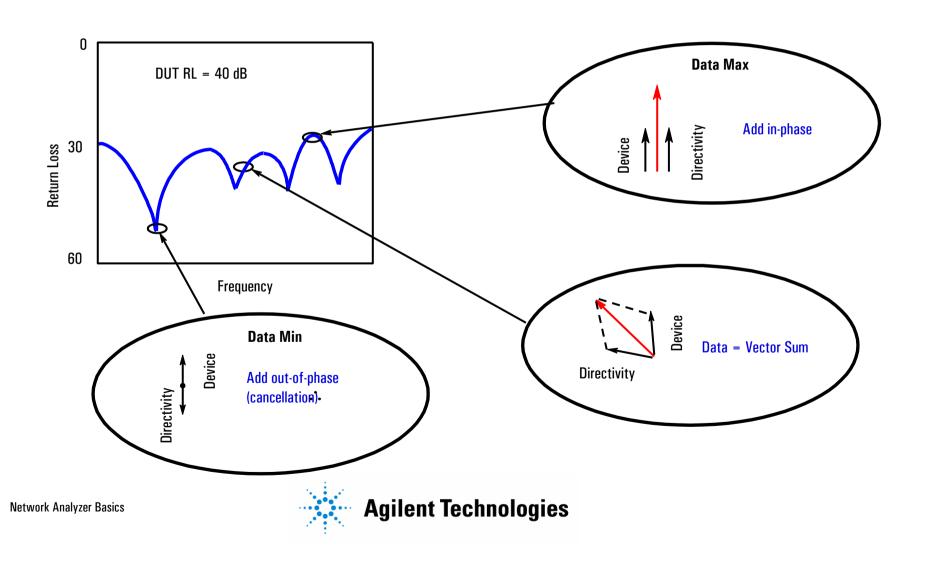


# **Directivity**

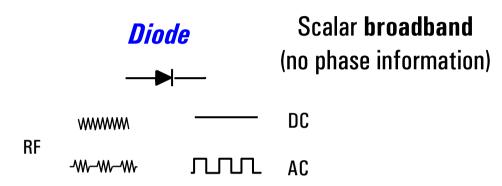
**Directivity** is a measure of how well a coupler can separate signals moving in opposite directions

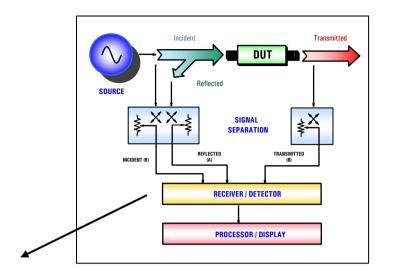


# Interaction of Directivity with the DUT (Without Error Correction)

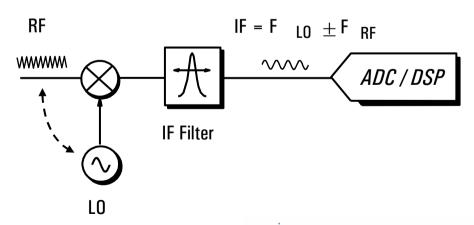


# **Detector Types**





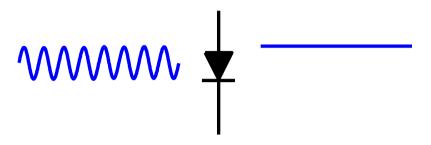
### **Tuned Receiver**



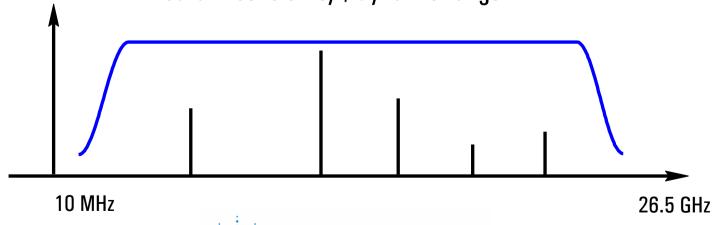
# **Vector** (magnitude and phase)



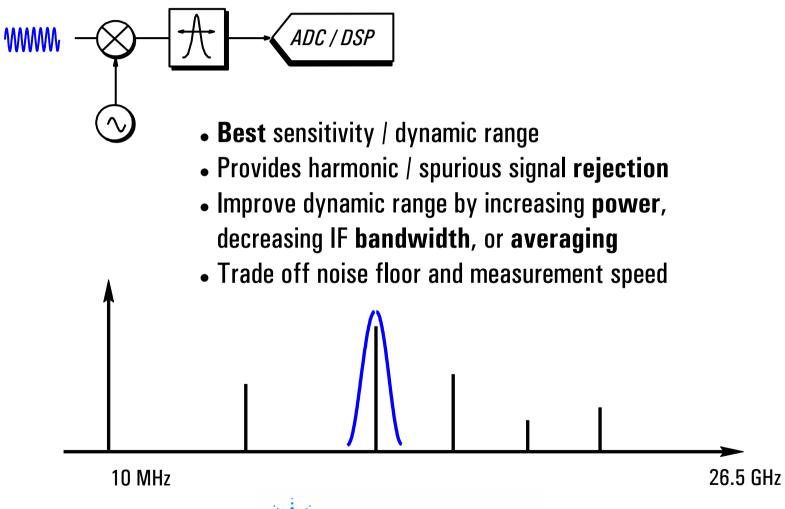
### **Broadband Diode Detection**



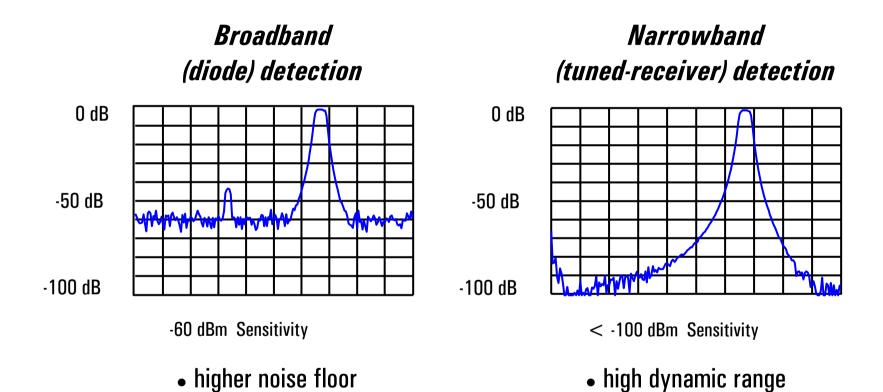
- Easy to make broadband
- Inexpensive compared to tuned receiver
- Good for measuring frequency-translating devices
- Improve dynamic range by increasing power
- Medium sensitivity / dynamic range



## Narrowband Detection - Tuned Receiver



# Comparison of Receiver Techniques



Dynamic range = maximum receiver power - receiver noise floor

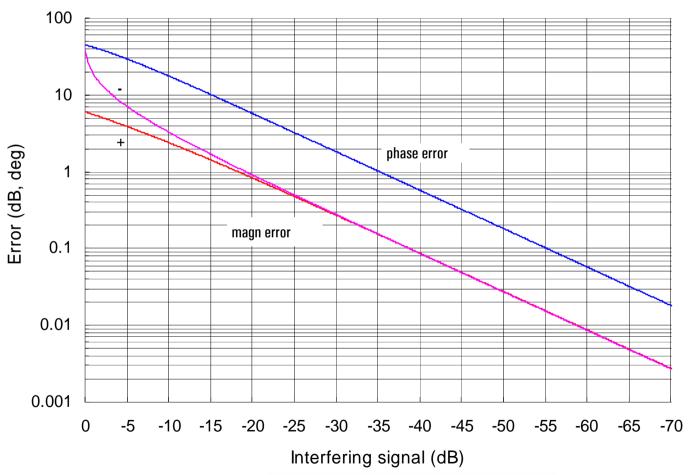
harmonic immunity



false responses

# **Dynamic Range and Accuracy**

### **Error Due to Interfering Signal**

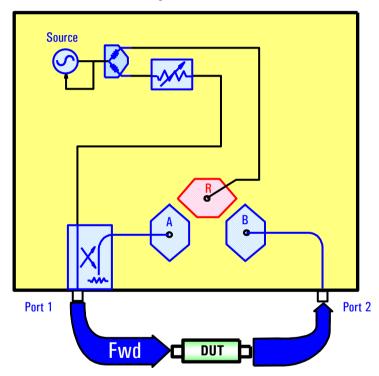


Dynamic range is very important for measurement accuracy!

Agilent Technologies

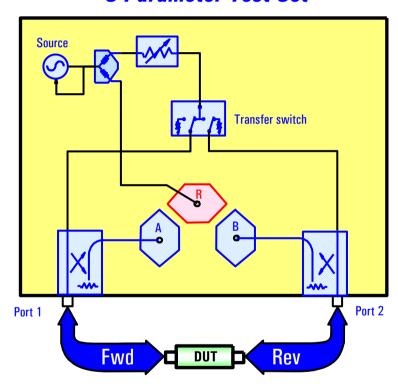
# T/R Versus S-Parameter Test Sets

### Transmission/Reflection Test Set



- RF always comes out port 1
- port 2 is always receiver
- response, one-port cal available

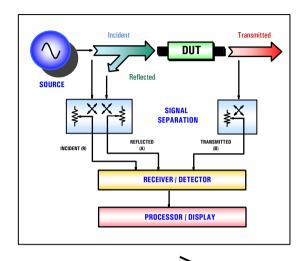
#### S-Parameter Test Set



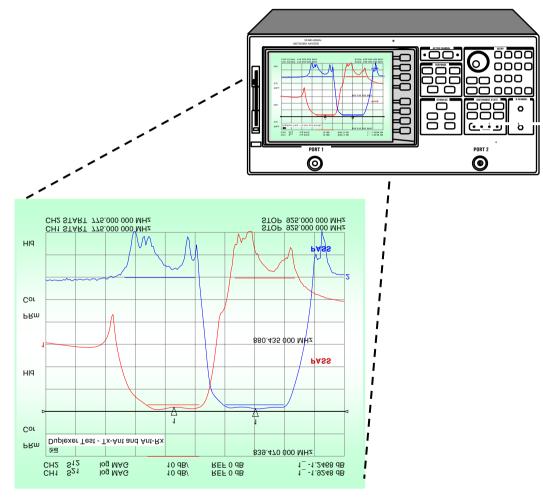
- RF comes out port 1 or port 2
- forward and reverse measurements
- two-port calibration possible



# **Processor / Display**



- markers
- limit lines
- pass/fail indicators
- linear/log formats
- grid/polar/Smith charts





### **Internal Measurement Automation**

Simple: recall states

More powerful:

#### Test sequencing

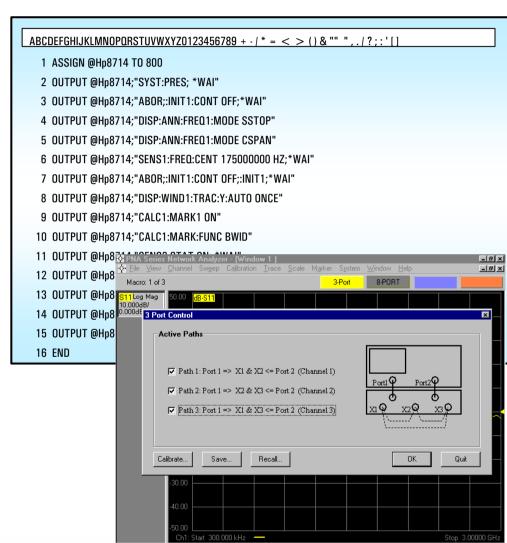
- available on 8753/8720 families
- keystroke recording
- some advanced functions

#### • IBASIC

- available on 8712 family
- sophisticated programs
- custom user interfaces

### Windows-compatible programs

- available on PNA Series
- Visual Basic, VEE, LabView, C++, ...





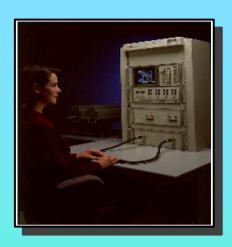
# Agilent's Series of HF Vector Analyzers

### **Microwave**



#### **8720/22 ET/ES series**

- 13.5, 20, 40 GHz
- economical
- fast, small, integrated
- test mixers, high-power amps



#### 8510C series

- 110 GHz *in coax*
- highest accuracy
- modular, flexible
- pulse systems

### RF



#### 8753ET/ES series

- 3, 6 GHz
- flexible hardware
- rich feature set
- offset and harmonic RF sweeps



#### **PNA Series**

- 3, 6, 9 GHz
- highest RF performance
- advanced connectivity
- internal automation, SCPI or COM/DCOM



# Agilent's LF/RF Vector Analyzers

### **Combination NA / SA**



#### 4395A/4396B

- 500 MHz (4395A), 1.8 GHz (4396B)
- impedance-measuring option
- fast, FFT-based spectrum analysis
- time-gated spectrum-analyzer option
- IBASIC
- standard test fixtures

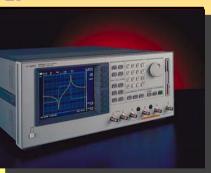
#### RF



### **8712/14 ET/ES series**

- 1.3, 3 GHz
- low cost
- narrowband and broadband detection
- IBASIC / LAN

#### LF

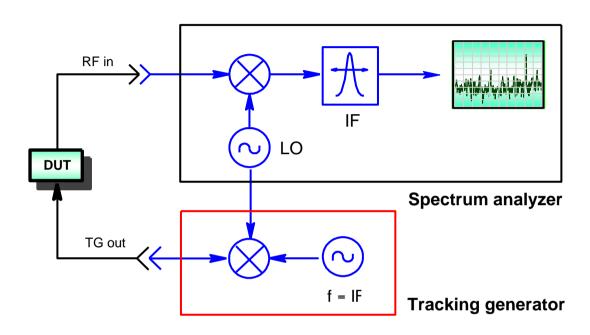


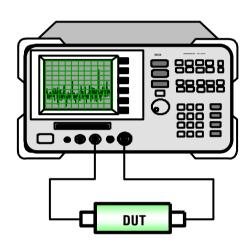
#### E5100A/B

- 180, 300 MHz
- economical
- fast, small
- target markets: crystals, resonators, filters
- equivalent-circuit models
- evaporation-monitor-function option



# Spectrum Analyzer / Tracking Generator



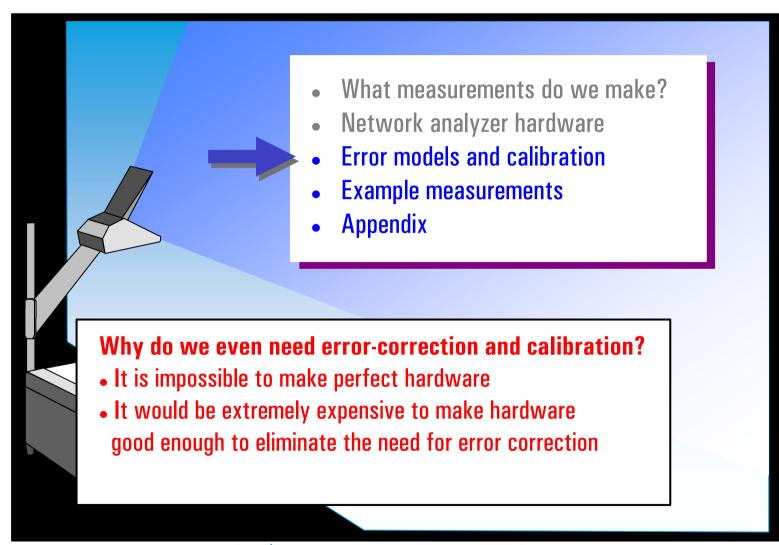


### Key differences from network analyzer:

- one channel -- no ratioed or phase measurements
- More **expensive** than scalar NA (but better dynamic range)
- Only error correction available is **normalization** (and possibly open-short averaging)
- Less accurate
- Small incremental cost if SA is required for other measurements

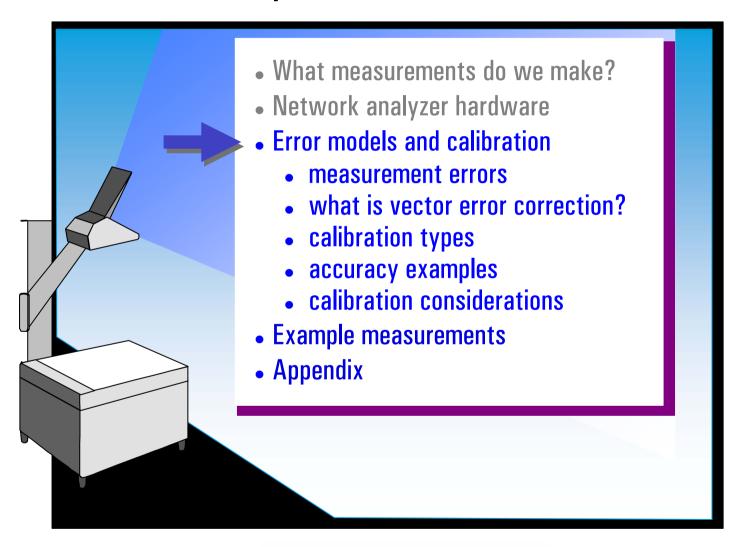


# Agenda





# **Calibration Topics**



# **Measurement Error Modeling**

### Systematic errors



- due to **imperfections** in the analyzer and test setup
- assumed to be time invariant (predictable)

#### Random errors

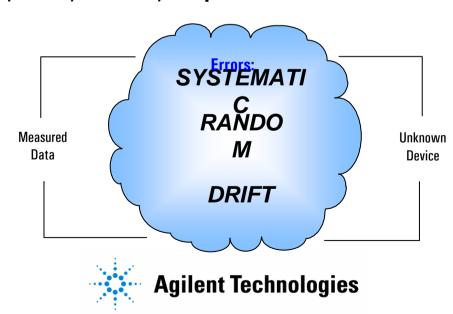


- vary with time in random fashion (unpredictable)
- main contributors: instrument noise, switch and connector repeatability

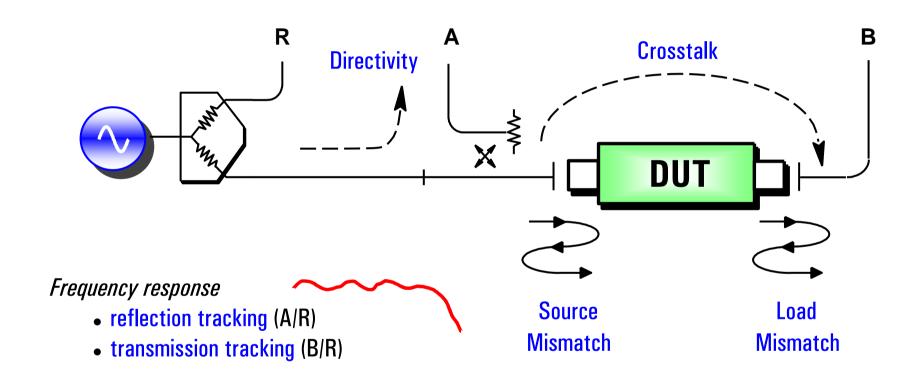
#### **Drift errors**



- due to system performance changing *after* a calibration has been done
- primarily caused by temperature variation



# Systematic Measurement Errors



Six forward and six reverse error terms yields 12 error terms for two-port devices



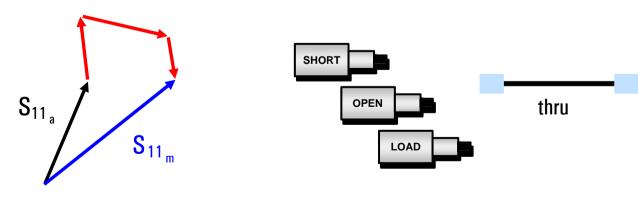
# **Types of Error Correction**

### • response (normalization)

- simple to perform
- only corrects for tracking errors
- stores reference trace in memory,
   then does data divided by memory

#### vector

- requires more standards
- requires an analyzer that can measure phase
- accounts for all major sources of systematic error



thru



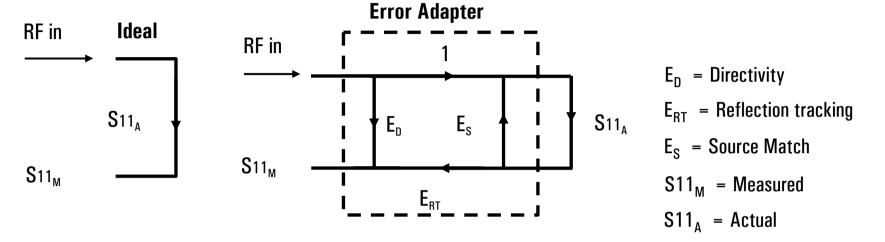
## What is Vector-Error Correction?

- Process of characterizing systematic error terms
  - measure known standards
  - remove effects from subsequent measurements
- 1-port calibration (reflection measurements)
  - only 3 systematic error terms measured
  - directivity, source match, and reflection tracking
- Full 2-port calibration (reflection and transmission measurements)
  - 12 systematic error terms measured
  - usually requires 12 measurements on four known standards (SOLT)
- Standards defined in cal kit definition file
  - network analyzer contains standard cal kit definitions
  - **CAL KIT DEFINITION MUST MATCH ACTUAL CAL KIT USED!**
  - User-built standards must be characterized and entered into user cal-kit





## Reflection: One-Port Model

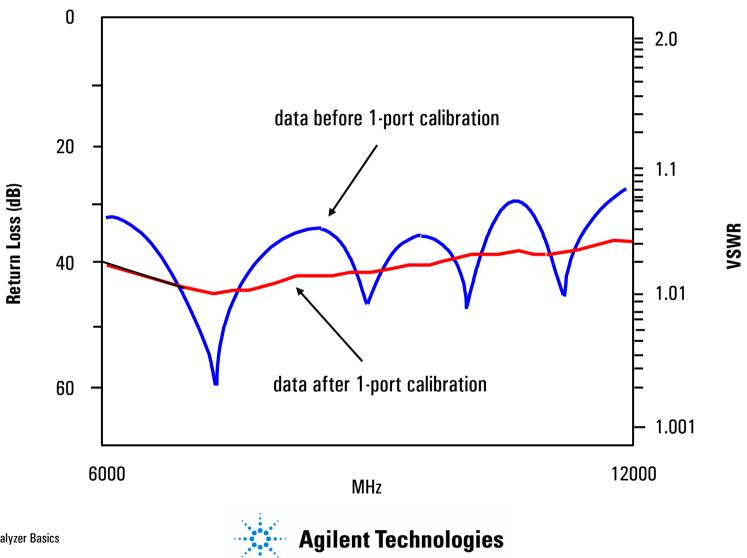


To solve for error terms, we measure 3 standards to generate 3 equations and 3 unknowns

- Assumes good termination at port two if testing two-port devices
- If using port 2 of NA *and* DUT reverse isolation is low (e.g., filter passband):
  - assumption of good termination is not valid
  - two-port error correction yields better results

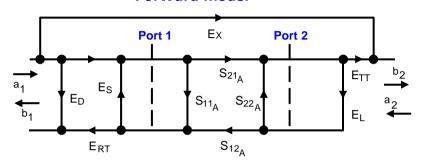


## Before and After One-Port Calibration



### **Two-Port Error Correction**

#### Forward model



En = fwd directivity

Es = fwd source match

E<sub>RT</sub> = fwd reflection tracking

 $E_{D'}$  = rev directivity

 $E_{S'}$  = rev source match

E<sub>RT'</sub> = rev reflection tracking

E<sub>L</sub> = fwd load match

 $E_{TT}$  = fwd transmission tracking

 $E_X$  = fwd isolation

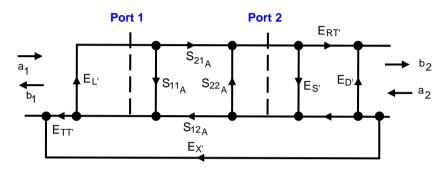
 $E_{1}$  = rev load match

E<sub>TT'</sub> = rev transmission tracking

 $E_{X'}$  = rev isolation

- Each actual S-parameter is a function of all four measured S-parameters
- Analyzer must make forward and reverse sweep to update any one S-parameter
- Luckily, you don't need to know these equations to use network analyzers!!!

#### Reverse model



$$S_{22a} = \frac{(\frac{S_{22m} - E_D}{E_{RL}})(1 + \frac{S_{11m} - E_D}{E_{RT}}E_S) - E_L'(\frac{S_{21m} - E_X}{E_{TT}})(\frac{S_{12m} - E_X}{E_{TT}})}{(1 + \frac{S_{11m} - E_D}{E_{RT}}E_S)(1 + \frac{S_{22m} - E_D'}{E_{RT}}E_S') - E_L'E_L(\frac{S_{21m} - E_X}{E_{TT}})(\frac{S_{12m} - E_X}{E_{TT}})}$$

$$S_{12a} = \frac{(\frac{S_{12m} - E_X}{E_{TT}})(1 + \frac{S_{11m} - E_D}{E_{RT}}(E_S - E_L'))}{(1 + \frac{S_{11m} - E_D}{E_{RT}}E_S)(1 + \frac{S_{22m} - E_D'}{E_{RT}}E_S') - E_L'E_L(\frac{S_{21m} - E_X}{E_{TT}})(\frac{S_{12m} - E_X}{E_{TT}})}$$

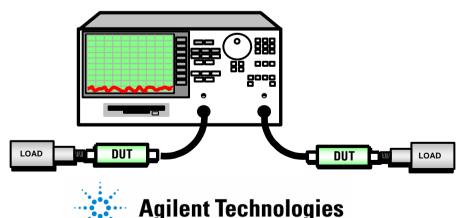
$$S_{21a} = \frac{(\frac{S_{21m} - E_X}{E_{TT}})(1 + \frac{S_{22m} - E_D}{E_{RT}'}(E_S' - E_L))}{(1 + \frac{S_{11m} - E_D}{E_{RT}}E_S)(1 + \frac{S_{22m} - E_D'}{E_{RT}'}E_S') - E_L'E_L(\frac{S_{21m} - E_X}{E_{TT}})(\frac{S_{12m} - E_X}{E_{TT}'})}$$

$$S_{11a} = \frac{(\frac{S_{11m} - E_D}{E_{RT}})(1 + \frac{S_{22m} - E_D}{E_{RT}}, E_{S'}) - E_L(\frac{S_{21m} - E_X}{E_{TT}})(\frac{S_{12m} - E_X}{E_{TT}})}{(1 + \frac{S_{11m} - E_D}{E_{RT}}, E_S)(1 + \frac{S_{22m} - E_D}{E_{RT}}, E_{S'}) - E_L'E_L(\frac{S_{21m} - E_X}{E_{TT}})(\frac{S_{12m} - E_X}{E_{TT}})}$$



# Crosstalk: Signal Leakage Between **Test Ports During Transmission**

- Can be a problem with:
  - high-isolation devices (e.g., switch in open position)
  - high-dynamic range devices (some filter stopbands)
- Isolation calibration
  - adds noise to error model (measuring near noise floor of system)
  - only perform if really needed (use averaging if necessary)
  - if crosstalk is **independent** of DUT match, use two terminations
  - if **dependent** on DUT match, use DUT with termination on output



DUT

### **Errors and Calibration Standards**

#### **UNCORRECTED**



- Convenient
- Generally not accurate
- No errors removed

#### **RESPONSE**



DUT

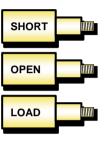
- Easy to perform
- Use when highest accuracy is not required
- Removes frequency response error



#### **ENHANCED-RESPONSE**

- Combines response and 1-port
- Corrects source match for transmission measurements

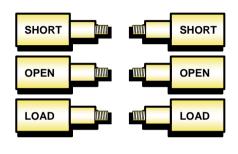
#### **1-PORT**





- For reflection measurements
- Need good termination for high accuracy with two-port devices
- Removes these errors:
   Directivity
   Source match
   Reflection tracking

#### **FULL 2-PORT**





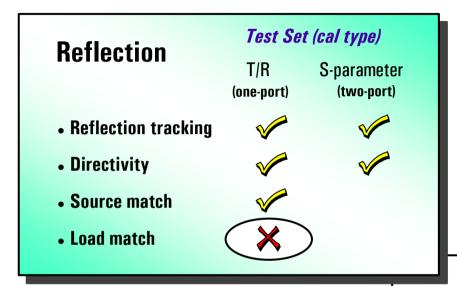
thru

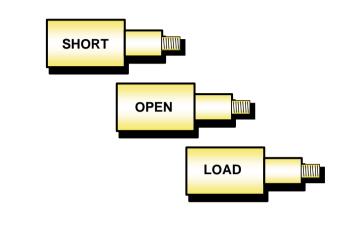
- Highest accuracy
- Removes these errors:

   Directivity
   Source, load match
   Reflection tracking
   Transmission tracking
   Crosstalk



# **Calibration Summary**





Test Set (cal type)



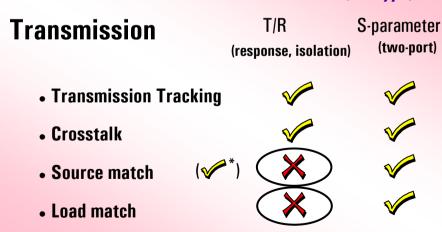
#### error can be corrected



#### error cannot be corrected

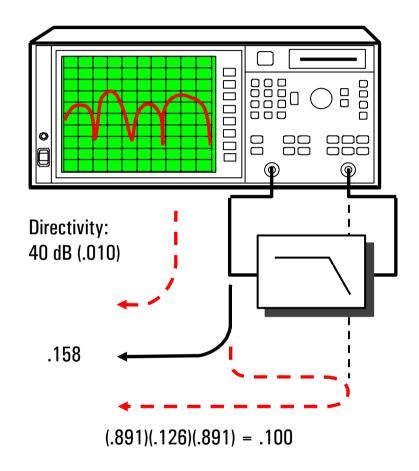


\* enhanced response cal corrects for source match during transmission measurements





# Reflection Example Using a One-Port Cal



Load match: 18 dB (.126)

### **DUT**

16 dB RL (.158) 1 dB loss (.891) Remember: convert all dB values to linear for uncertainty calculations!

$$\rho$$
 or loss<sub>(linear)</sub> =  $10^{\left(\frac{-dB}{20}\right)}$ 

### Measurement uncertainty:

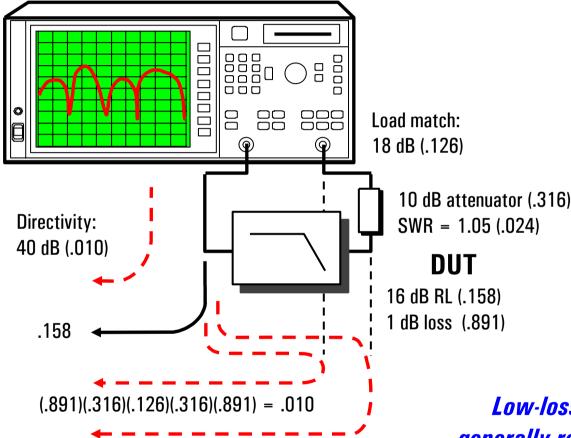
$$-20 * log (.158 + .100 + .010)$$

$$= 11.4 dB (-4.6dB)$$

$$= 26.4 dB (+10.4 dB)$$



# Using a One-Port Cal + Attenuator



(.891)(.024)(.891) = .019

Worst-case error = .010 + .010 + .019 = .039

**Measurement uncertainty:** 

-20 \* log (.158 + .039)

= 14.1 dB (-1.9 dB)

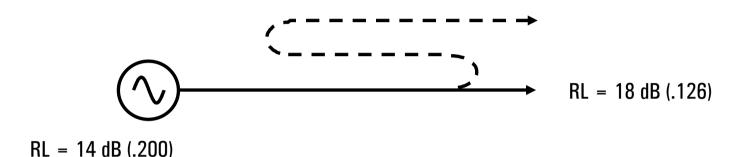
-20 \* log (.158 - .039)

= 18.5 dB (+2.5 dB)

Low-loss bi-directional devices generally require two-port calibration for low measurement uncertainty



# Transmission Example Using Response Cal



Thru calibration (normalization) builds error into measurement due to source and load match interaction

### **Calibration Uncertainty**

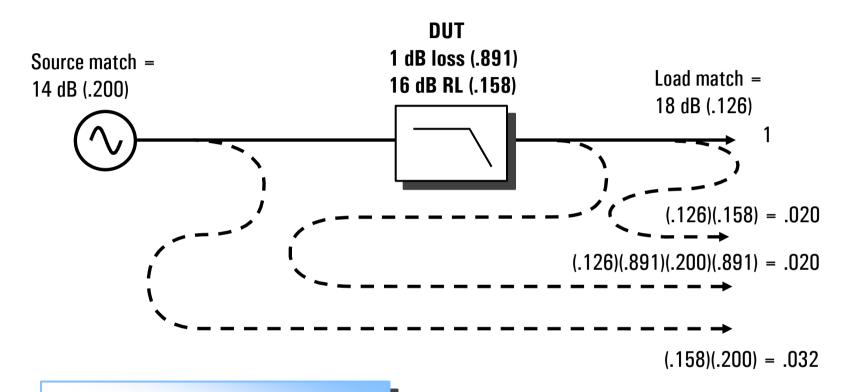
$$= (1 \pm \rho_{\rm S} \rho_{\rm L})$$

$$= (1 \pm (.200)(.126))$$

$$=$$
  $\pm$  0.22 dB



# Filter Measurement with Response Cal



### **Total measurement uncertainty:**

$$+0.60 + 0.22 = + 0.82 \text{ dB}$$
  
-0.65 - 0.22 = - 0.87 dB

#### Measurement uncertainty

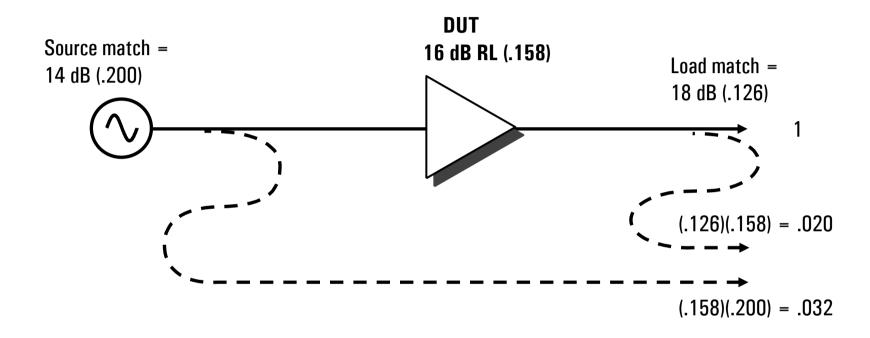
$$= 1 \pm (.020 + .020 + .032)$$

$$= 1 \pm .072$$

$$= + 0.60 dB$$



# Measuring Amplifiers with a Response Cal



### **Total measurement uncertainty:**

$$+0.44 + 0.22 = +0.66 \text{ dB}$$

-0.46 - 0.22 = -0.68 dB

#### Measurement uncertainty

$$= 1 \pm (.020 + .032)$$

$$= 1 \pm .052$$

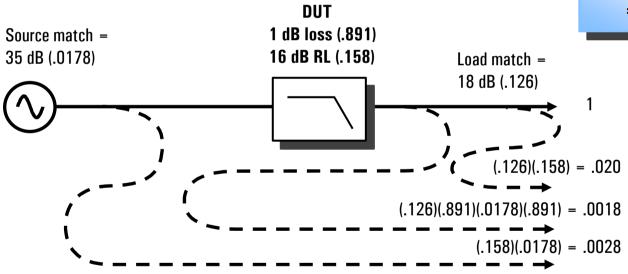
$$= + 0.44 dB$$



# Filter Measurements using the Enhanced Response

## **Calibration**

Effective source match = 35 dB!



### **Calibration Uncertainty**

$$= (1 \pm \rho_s \rho_l)$$

$$= (1 \pm (.0178)(.126)$$

$$= \pm .02 dB$$

#### Measurement uncertainty

$$= 1 \pm (.020 + .0018 + .0028)$$

$$= 1 + .0246$$

$$= + 0.211 dB$$

Total measurement uncertainty:

$$0.22 + .02 = \pm 0.24 dB$$

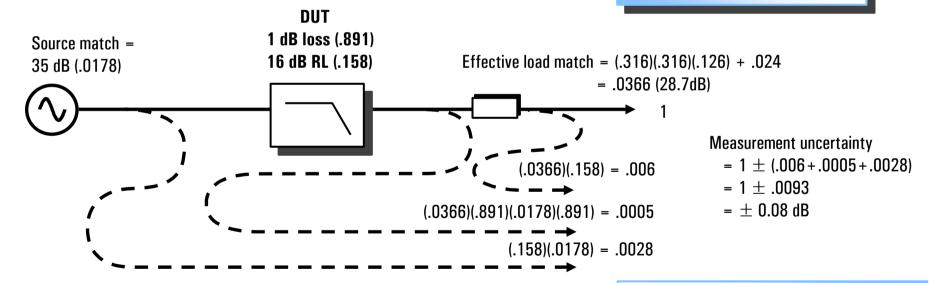


# Using the *Enhanced Response*Calibration Plus an Attenuator

10 dB attenuator (.316) SWR = 1.05 (.024 linear or 32.4 dB) Analyzer load match = 18 dB (.126)

# Calibration Uncertainty = $(1 \pm \rho_s \rho_l)$

 $= (1 \pm (.0178)(.0366))$ =  $\pm .01 dB$ 



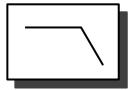
**Total measurement uncertainty:** 

$$0.01 + .08 = \pm 0.09 \, dB$$



# Calculating Measurement Uncertainty After a

**Two-Port Calibration** 



DUT 1 dB loss (.891) 16 dB RL (.158)

# Corrected error terms: (8753ES 1.3-3 GHz Type-N)

Directivity = 47 dB
Source match = 36 dB
Load match = 47 dB
Refl. tracking = .019 dB
Trans. tracking = .026 dB
Isolation = 100 dB

### **Reflection uncertainty**

= 
$$0.128 \mp .0088 = 10 \text{ qB} + 0.23 \text{ qB}' - 0.44 \text{ qB} \text{ (mozst-case)}$$
  
 $S_{11m} = S_{11a} \pm (E_D + S_{11a}^2 E_S + S_{21a} S_{12a} E_L + S_{11a} (1 - E_{RT}))$   
=  $0.158 \pm (.0045 + 0.158^2 * .0158 + 0.891^2 * .0045 + 0.158 * .0022)$ 

### **Transmission uncertainty**

= 
$$0.881 \mp .0029 = 1$$
 qB  $\mp 0.02$  qB (mountain (mountain section))  
 $S_{21m} = S_{21a} \pm S_{21a} (E_I / S_{21a} + S_{11a} E_S + S_{21a} S_{12a} E_S E_L + S_{22a} E_L + (1 - E_{TT}))$   
=  $0.891 \pm 0.891(10^{-6} / 0.891 + 0.158*.0158 + 0.891^2*.0158*.0045 + 0.158*.0045 + 0.03)$ 



# **Comparison of Measurement Examples**

### Reflection

Calibration type	Measurement uncertainty
One-port	-4.6/ 10.4 dB
One-port + attenuator	-1.9/ 2.5 dB
Two-port	-0.44/ 0.53 dB

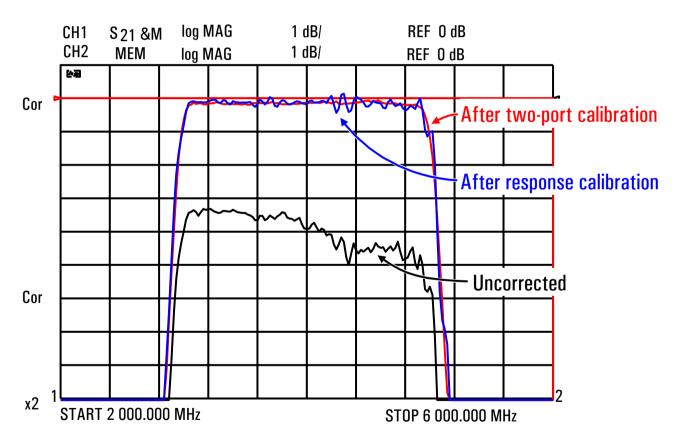
### **Transmission**

Calibration type	Calibration uncertainty	Measurement uncertainty	Total uncertainty
Response	±0.22 dB	0.60/ -0.65 dB	0.82/ -0.87
Enhanced response	±0.02 dB	±0.22 dB	±0.24
Enh. response + attenuator	<u>+</u> 0.01 dB	±0.08 dB	±0.09
Two port			±0.05



# Response versus Two-Port Calibration

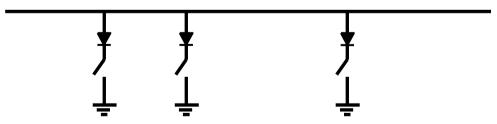
### **Measuring filter insertion loss**



# ECal: Electronic Calibration (85060/90 series)

- Variety of modules cover 30 kHz to 26.5 GHz
- Six connector types available (50  $\Omega$  and 75  $\Omega$ )
- Single-connection
  - reduces calibration time
  - makes calibrations easy to perform
  - minimizes wear on cables and standards
  - eliminates operator errors
- Highly repeatable temperature-compensated terminations provide excellent accuracy

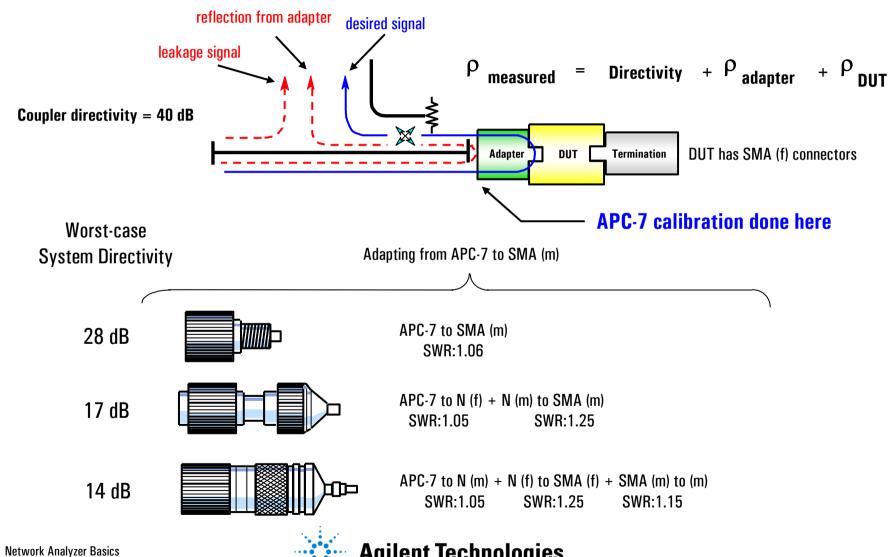




Microwave modules use a transmission line shunted by PIN-diode switches in various combinations



# **Adapter Considerations**



# Calibrating Non-Insertable Devices

#### When doing a through cal, normally test ports mate directly

- cables can be connected directly without an adapter
- result is a zero-length through

#### What is an insertable device?

- has same type of connector, but different sex on each port
- has same type of sexless connector on each port (e.g. APC-7)

#### What is a non-insertable device?

- one that cannot be inserted in place of a zero-length through
- has same connectors on each port (type and sex)
- has different type of connector on each port
   (e.g., waveguide on one port, coaxial on the other)

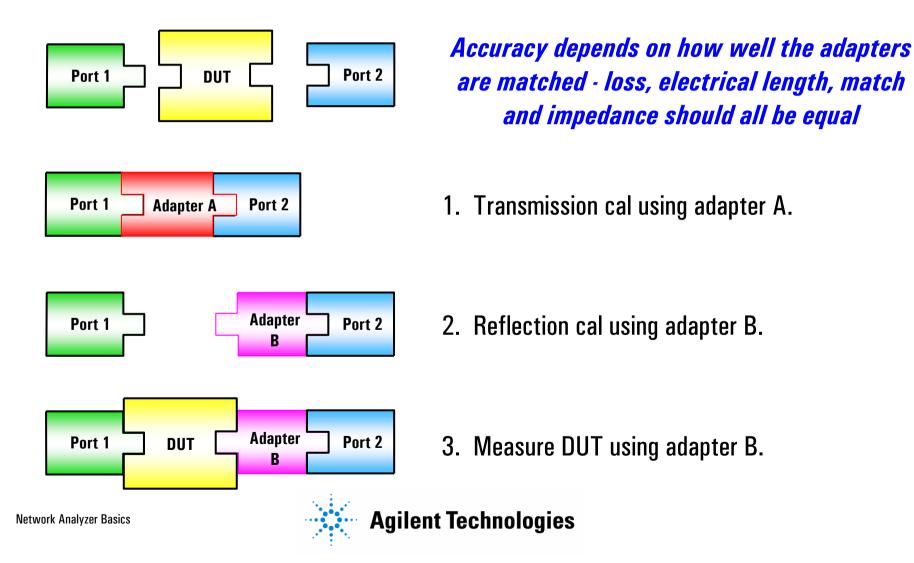
#### What calibration choices do I have for non-insertable devices?

- use an *uncharacterized* through adapter
- use a *characterized* through adapter (modify cal-kit definition)
- swap equal adapters
- adapter removal



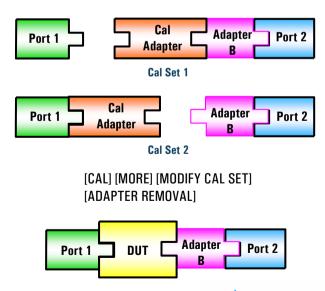


## **Swap Equal Adapters Method**



## **Adapter Removal Calibration**

- Calibration is very accurate and traceable
- In firmware of 8753, 8720 and 8510 series
- Also accomplished with ECal modules (85060/90)
- Uses adapter with same connectors as DUT
- Must specify electrical length of adapter to within 1/4 wavelength of highest frequency (to avoid phase ambiguity)



Port 1 DUT Port 2

- 1. Perform 2-port cal with adapter on port 2. Save in cal set 1.
- 2. Perform 2-port cal with adapter on port 1. Save in cal set 2.
- 3. Use ADAPTER REMOVAL to generate new cal set.
- 4. Measure DUT without cal adapter.

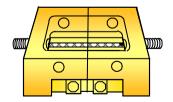


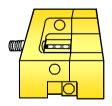
#### Thru-Reflect-Line (TRL) Calibration

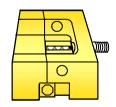
We know about Short-Open-Load-Thru (SOLT) calibration... What is TRL?

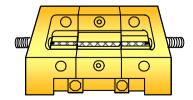
- A two-port calibration technique
- Good for noncoaxial environments (waveguide, fixtures, wafer probing)
- Uses the same 12-term error model as the more common SOLT cal
- Uses practical calibration standards that are easily fabricated and characterized
- Two variations: TRL (requires 4 receivers) and TRL\* (only three receivers needed)
- Other variations: Line-Reflect-Match (LRM), Thru-Reflect-Match (TRM), plus many others

TRL was developed for non-coaxial microwave measurements



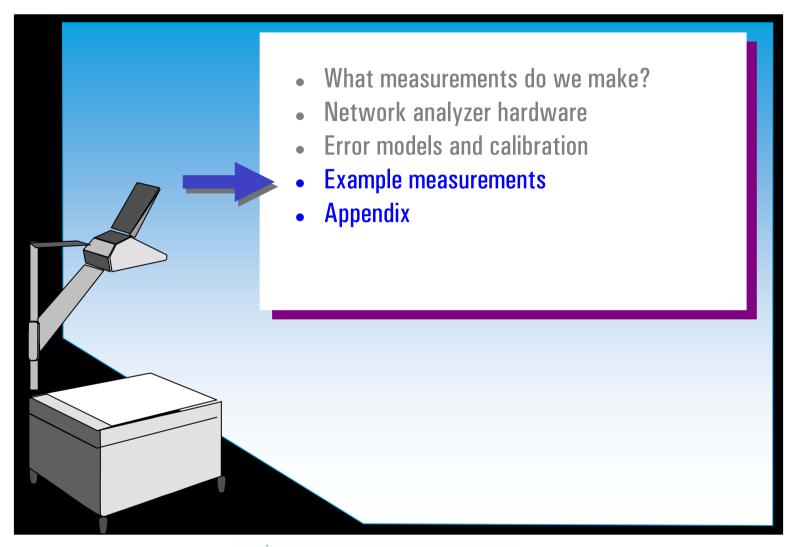






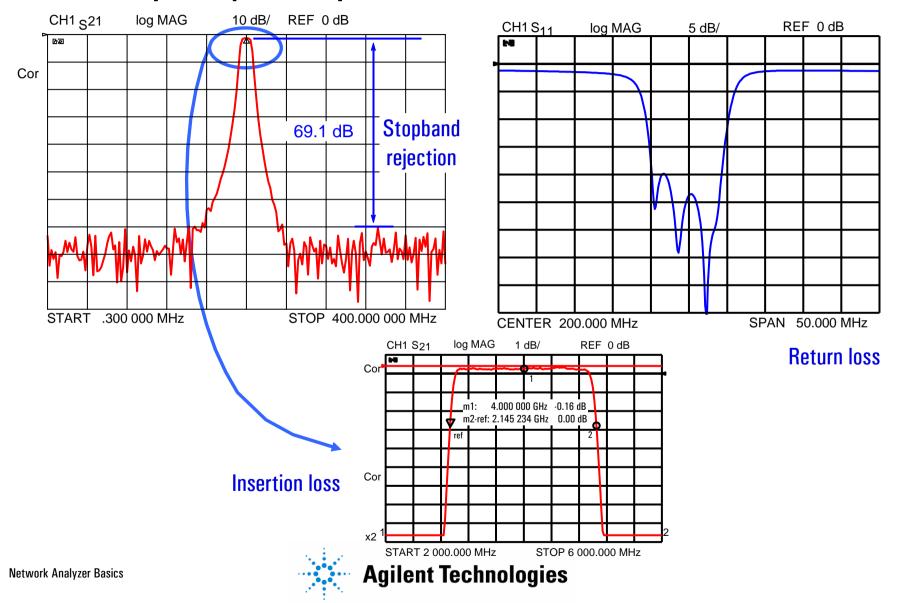


# Agenda

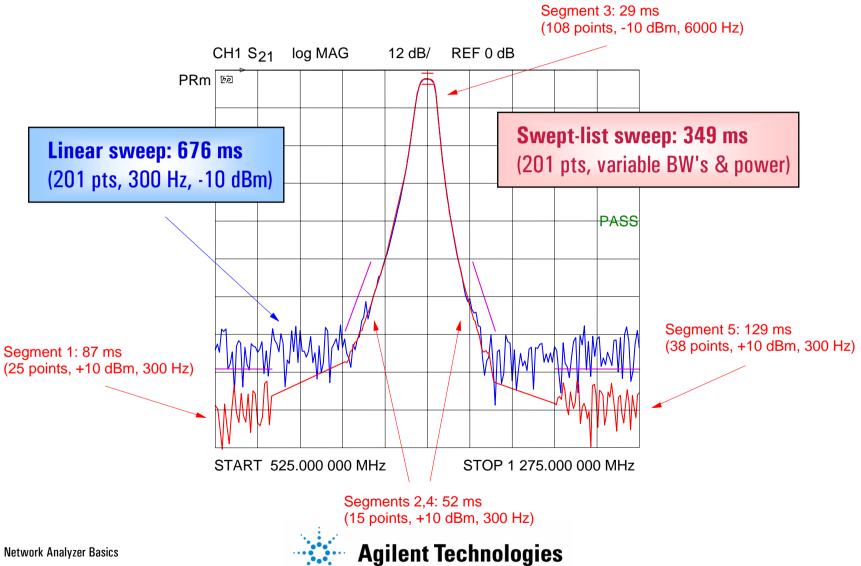




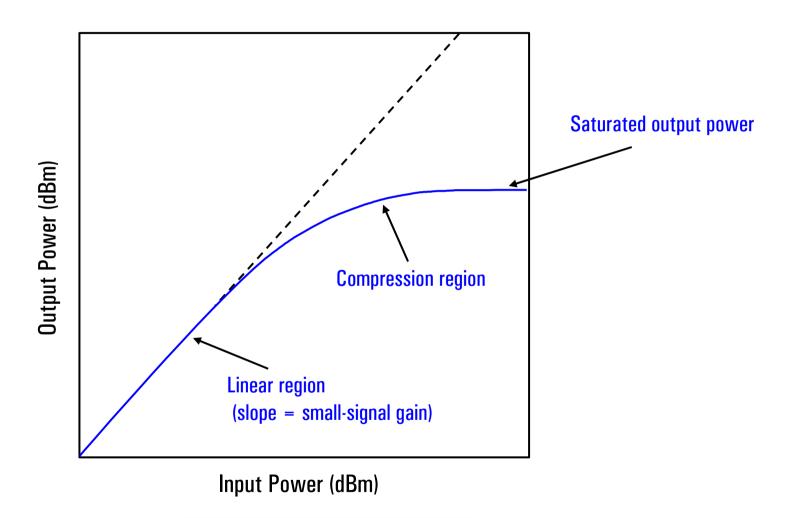
# Frequency Sweep - Filter Test



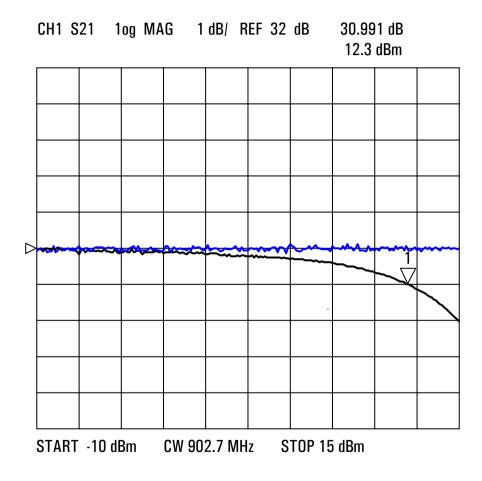
## Optimize Filter Measurements with Swept-List Mode



# **Power Sweeps - Compression**



# **Power Sweep - Gain Compression**

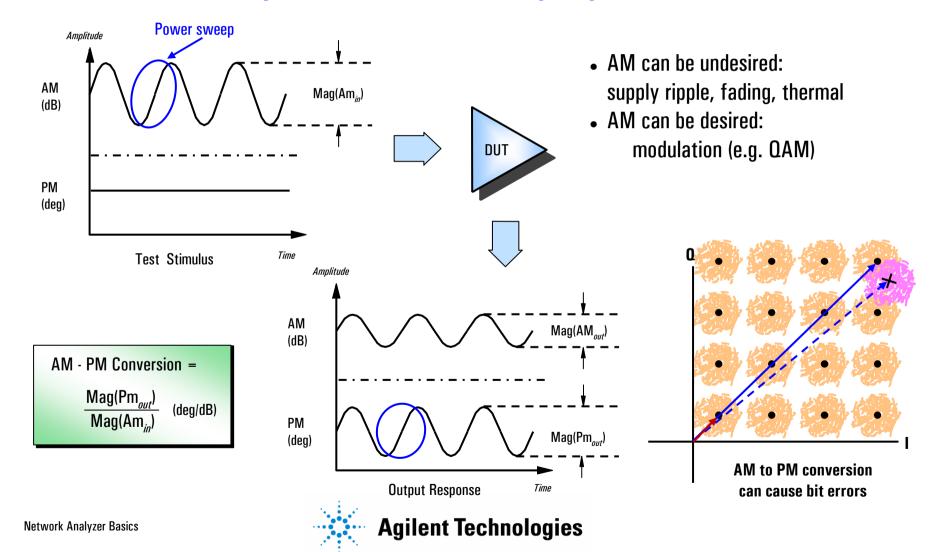


1 dB compression: input power resulting in 1 dB *drop* in gain

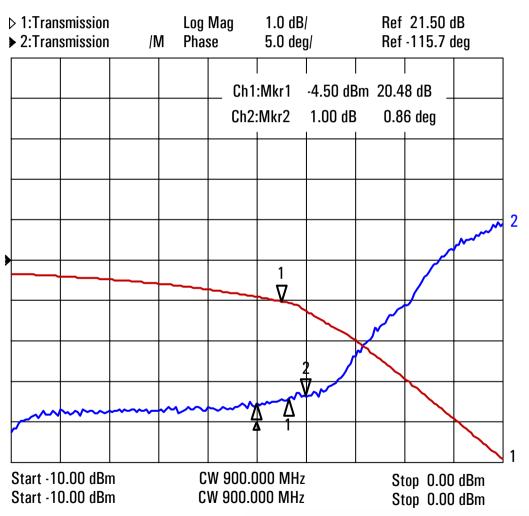


#### AM to PM Conversion

#### Measure of phase deviation caused by amplitude variations



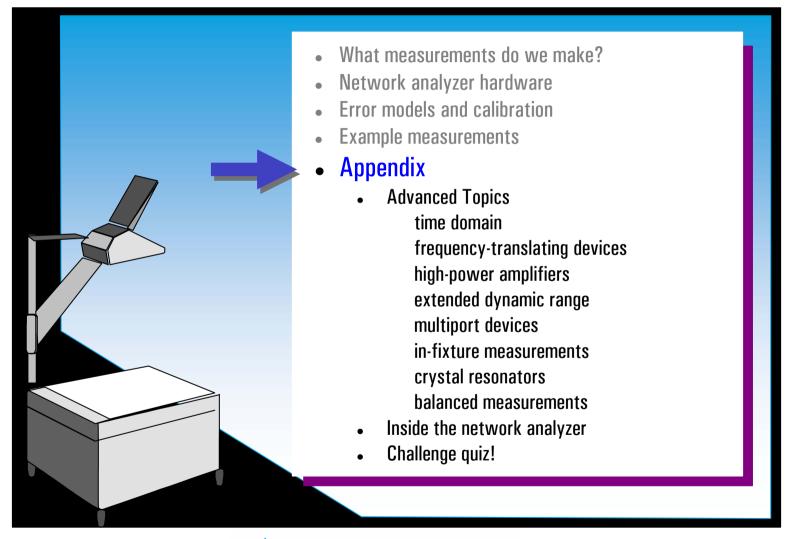
# Measuring AM to PM Conversion



- Use transmission setup with a power sweep
- Display phase of S21
- AM PM = 0.86 deg/dB



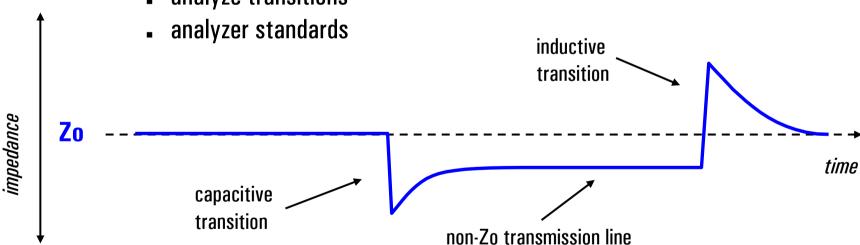
## Agenda





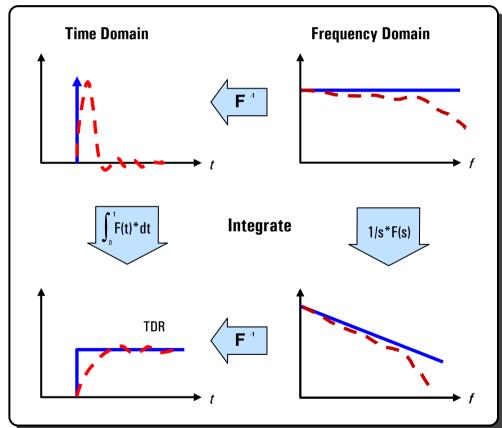
#### Time-Domain Reflectometry (TDR)

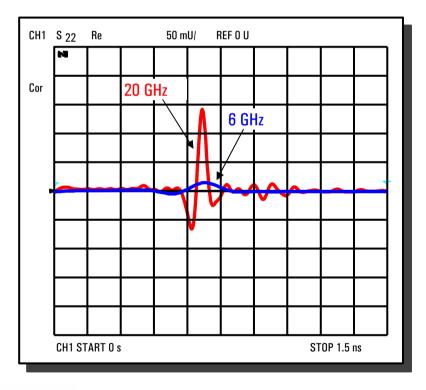
- What is TDR?
  - time-domain reflectometry
  - analyze impedance versus time
  - distinguish between inductive and capacitive transitions
- With gating:
  - analyze transitions



## TDR Basics Using a Network Analyzer

- start with broadband frequency sweep (often requires microwave VNA)
- use inverse-Fourier transform to compute time-domain
- resolution inversely proportionate to frequency span

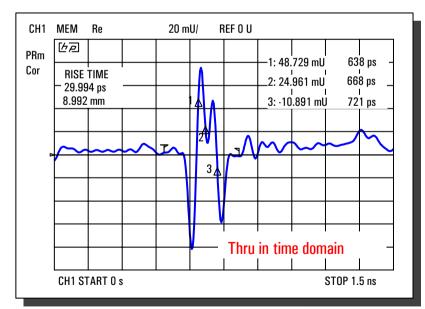


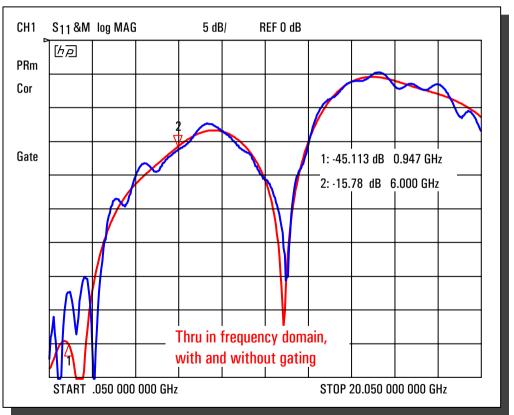




# **Time-Domain Gating**

- TDR and gating can remove undesired reflections (a form of error correction)
- Only useful for **broadband** devices (a load or thru for example)
- Define gate to only include DUT
- Use two-port calibration







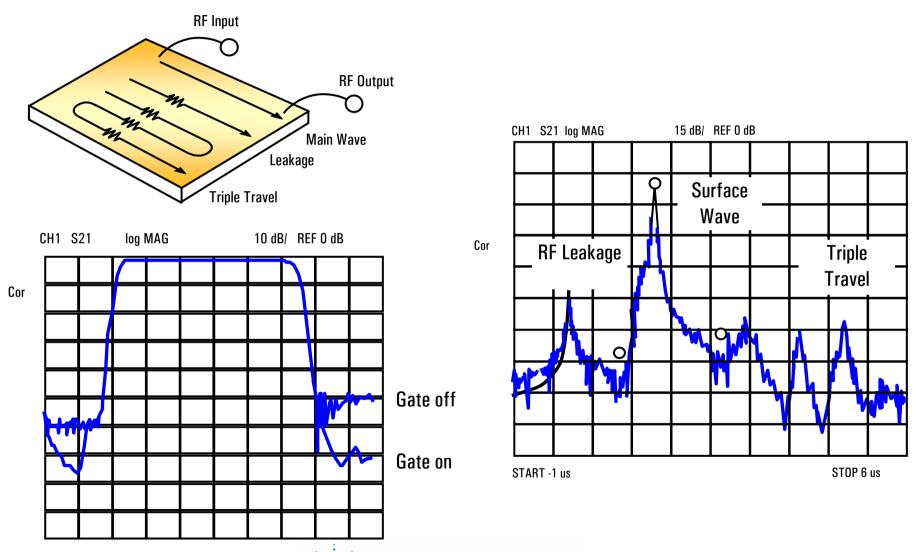
# Ten Steps for Performing TDR

- 1. Set up desired frequency range (need wide span for good spatial resolution)
- 2. Under SYSTEM, transform menu, press "set freg low pass"
- 3. Perform one- or two-port calibration
- 4. Select S11 measurement \*
- 5. Turn on transform (low pass step) \*
- 6. Set format to real \*
- 7. Adjust transform window to trade off rise time with ringing and overshoot \*
- 8. Adjust start and stop times if desired
- 9. For gating:
  - set start and stop frequencies for gate
  - turn gating on \*
  - adjust gate shape to trade off resolution with ripple \*
- 10. To display gated response in frequency domain
  - turn transform off (leave gating on) \*
  - change format to log-magnitude \*

\* If using two channels (even if coupled), these parameters must be set independently for second channel



#### **Time-Domain Transmission**



**Network Analyzer Basics** 

Agilent Technologies

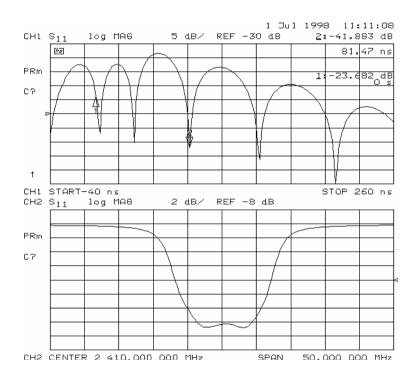
# Time-Domain Filter Tuning



- Deterministic method used for tuning cavity-resonator filters
- Traditional frequency-domain tuning is very difficult:
  - lots of training needed
  - may take 20 to 90 minutes to tune a single filter
- Need VNA with fast sweep speeds and fast time-domain processing



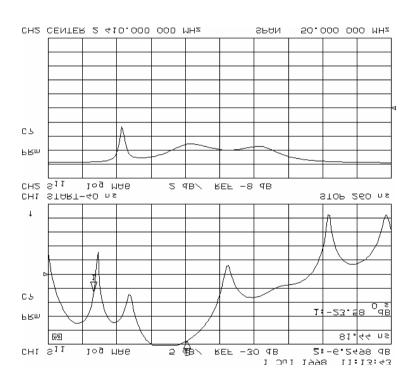
#### Filter Reflection in Time Domain



- Set analyzer's center frequency
  - = center frequency of the filter
- Measure  $S_{11}$  or  $S_{22}$  in the time domain
- Nulls in the time-domain response correspond to individual resonators in filter



# **Tuning Resonator #3**

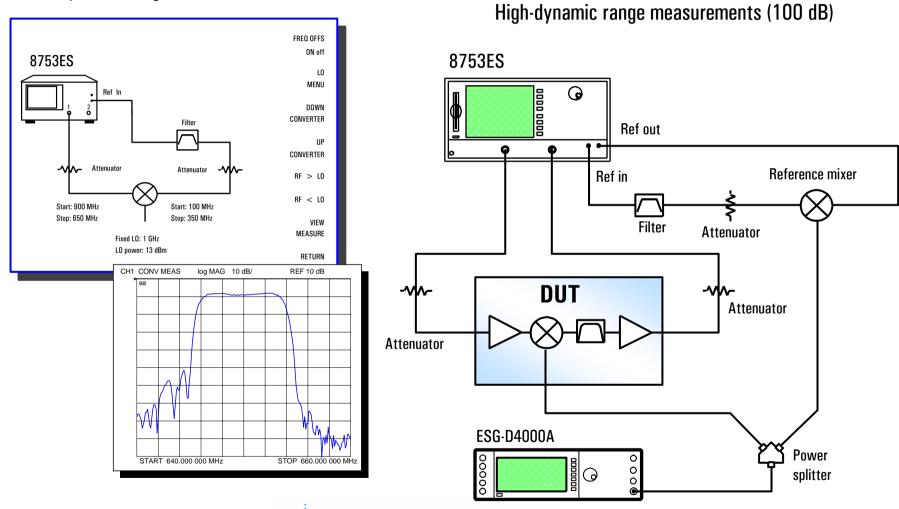


- Easier to identify mistuned resonator in time-domain: null #3 is missing
- Hard to tell which resonator is mistuned from frequency-domain response
- Adjust resonators by minimizing null
- Adjust coupling apertures using the peaks in-between the dips

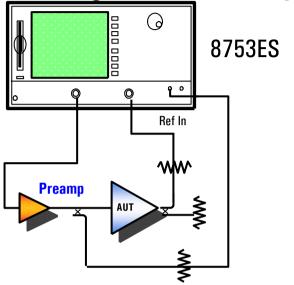


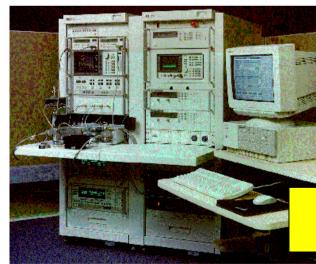
# Frequency-Translating Devices

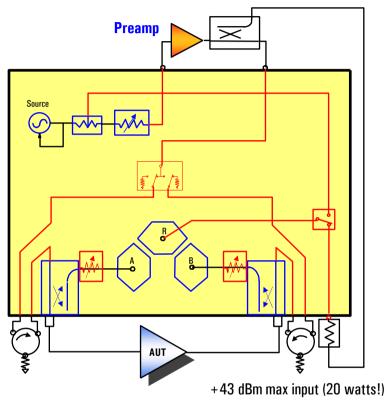
Medium-dynamic range measurements (35 dB)



# **High-Power Amplifiers**





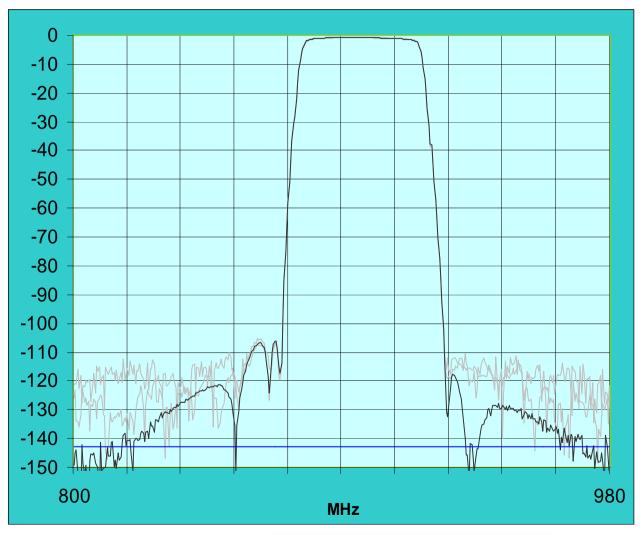


8720ES Option 085

85118A High-Power Amplifier Test System



# **High-Dynamic Range Measurements**



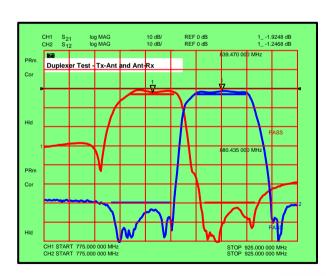
Take advantage of extended dynamic range with direct-receiver access



## Multiport Device Test



8753 H39

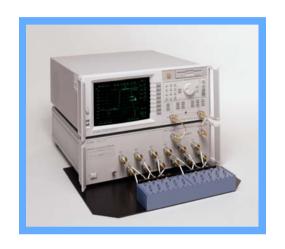


#### Multiport analyzers and test sets:

- improve **throughput** by reducing the number of connections to DUTs with more than two ports
- allow simultaneous viewing of two paths (good for tuning duplexers)
- include mechanical or solid-state switches,
   50 or 75 ohms
- degrade raw performance so calibration is a must (use two-port cals whenever possible)
- Agilent offers a variety of standard and custom multiport analyzers and test sets

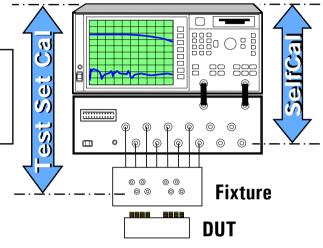


#### 87050E/87075C Standard Multiport Test Sets



#### Once a month:

perform a **Test Set Cal** with external standards to remove systematic errors in the analyzer, test set, cables, and fixture



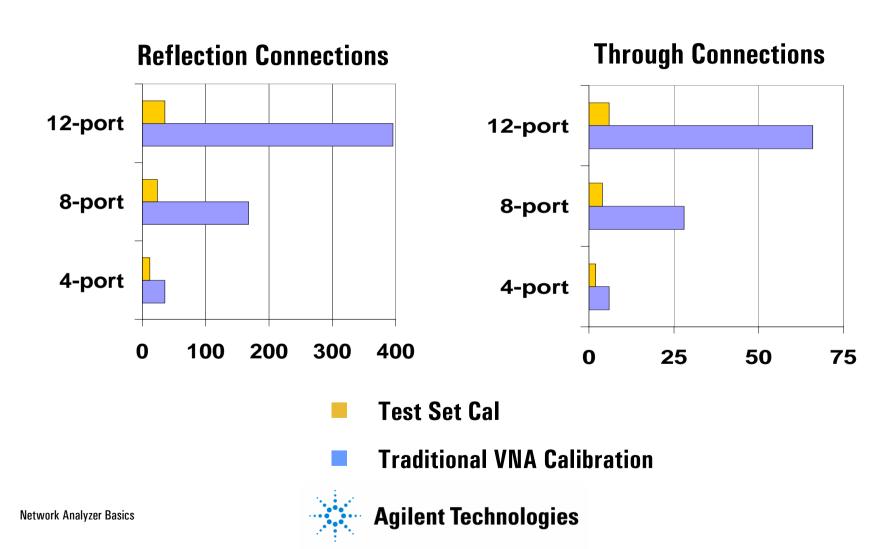
- For use with 8712E family
- 50  $\Omega$ : 3 MHz to 2.2 GHz, 4, 8, or 12 ports
- 75  $\Omega$ : 3 MHz to 1.3 GHz, 6 or 12 ports
- Test Set Cal and SelfCal dramatically improve calibration times
- Systems offer fully-specified performance at test ports

#### Once an hour:

automatically perform a **SelfCal** using internal standards to remove systematic errors in the analyzer and test set



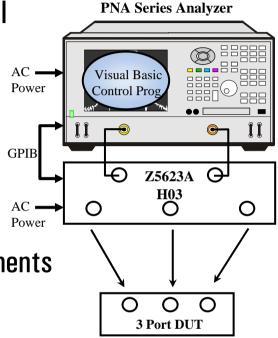
# Test Set Cal Eliminates Redundant Connections of Calibration Standards

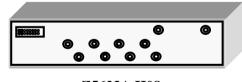


# PNA Series plus External Test Set

 Test set controlled via GPIB and Agilent-supplied Visual Basic program executed from PNA Series analyzer

- Two port error correction available
- Z5623A H03
  - 3 port external test set
  - Solid-state switching for fast, repeatable measurements
- Z5623A H08
  - 8 port external test set
  - Mechanical switching for best RF performance



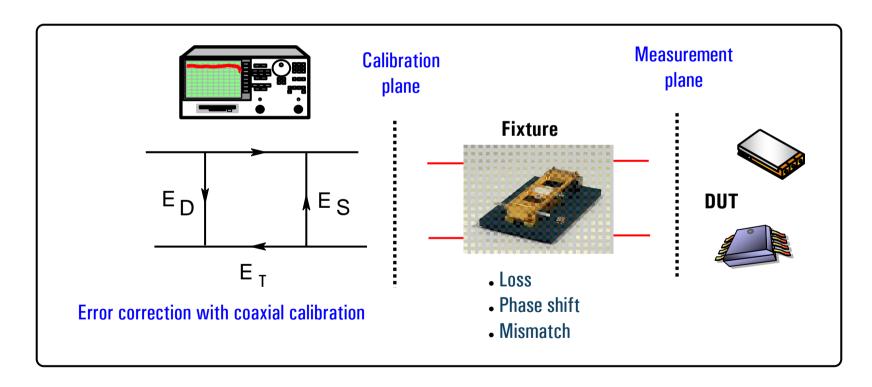


Z5623A H08



#### **In-Fixture Measurements**

**Measurement problem:** coaxial calibration plane is not the same as the in-fixture measurement plane

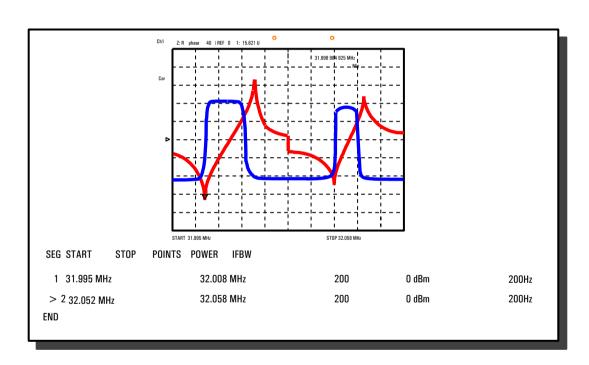




# **Characterizing Crystal Resonators/Filters**

#### E5100A/B Network Analyzer





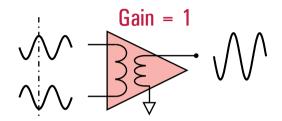
**Example of crystal resonator measurement** 



#### What are Balanced Devices?

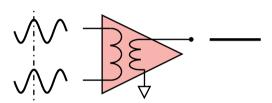
Ideally, respond to differential and reject common-mode signals

Differential-mode signal

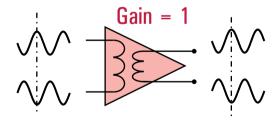


Balanced to single-ended

Common-mode signal (EMI or ground noise)

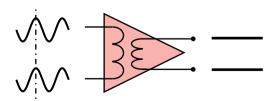


Differential-mode signal



**Fully balanced** 

Common-mode signal (EMI or ground noise)



**Agilent Technologies** 

#### What about Non-Ideal Devices?

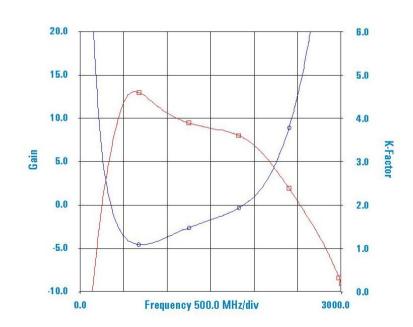
Mode conversions occur... Differential to commonmode conversion **Generates EMI Susceptible to EMI** Common-mode to differential conversion



#### So What?

#### RF and digital designers need to characterize:

- Differential to differential mode (desired operation)
- Mode conversions (undesired operation)
- Operation in non-50-ohm environments
- Other differential parameters:
  - common-mode rejection ratio
  - K-factor
  - phase/amplitude balance
  - conjugate matches





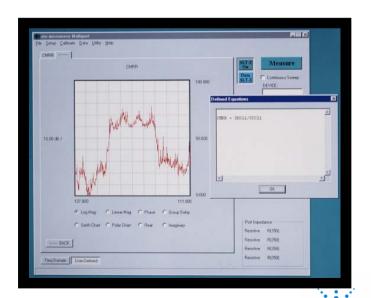
#### **Agilent Solution for Balanced Measurements**

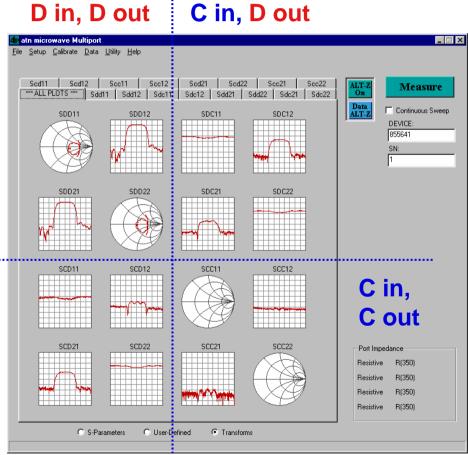
Data presented as mixed-mode S-parameters

D = differential mode C = common mode

Excellent dynamic range and accuracy

 Many important features such as time domain, impedance re-normalization, user parameters...





**Agilent Technologies** 

D in.

C out

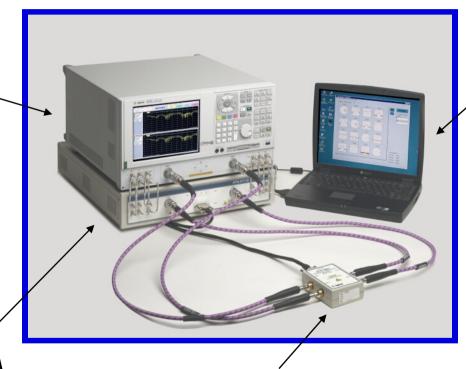
#### 6 GHz Solution based on the PNA Series

#### Network Analyzer

- option 015 (allows standard VNA use)
- signal source
- receiver

#### **Test Set**

- adds 2 ports to VNA
- includes switches, 2 couplers



Optional 4-port ECal module

#### Software

- instrument control
- calibration routines
- error correction
- measurement routines
- "user" features
- time domain



# **Target Markets**

#### Wireless Communications

- Balanced topology less susceptible to EMI, noise
- Less shielding required
- RF grounding less critical
- Better RF performance,
   smaller, lighter phones
- LVDS extends battery life



#### Signal Integrity

- Verify waveform quality of high speed digital signals
- Engineers primarily interested in time-domain analysis



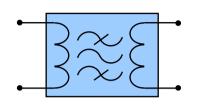
### **Target Devices**

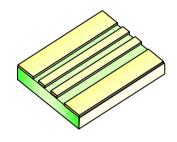
#### **RF/Microwave Components**

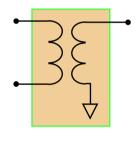
- Balanced filters
- Differential/push-pull amplifiers
- Baluns
- Balanced transmission lines
- Cable connectors
- Couplers\*, circulators\*, splitters/combiners\*



\* single-ended devices that need 4-port error correction





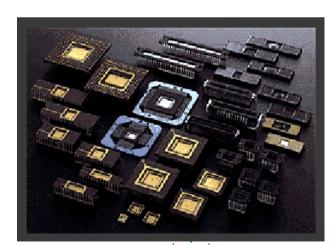




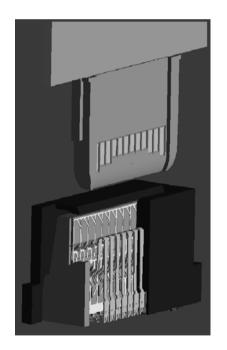
### **Target Devices**

#### **Digital Design**

- PCB backplanes
- PCB interconnects
- Sockets, packages
- High-speed serial interconnects
   (Ethernet, Firewire, Infiniband, USB ...)

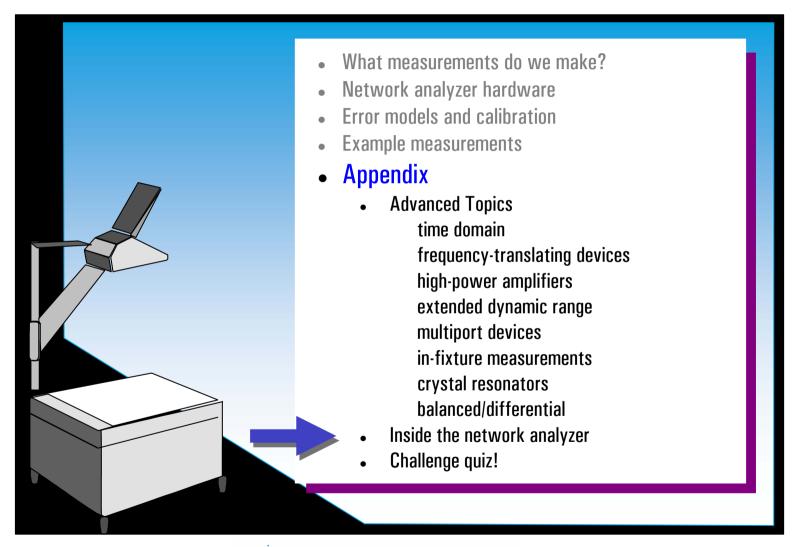






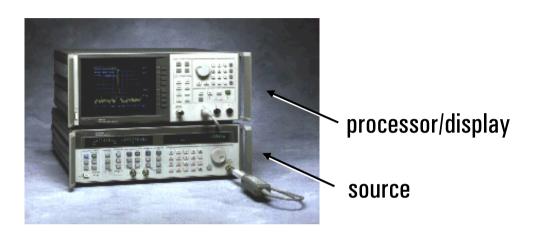


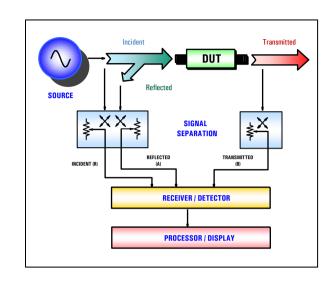
#### Agenda





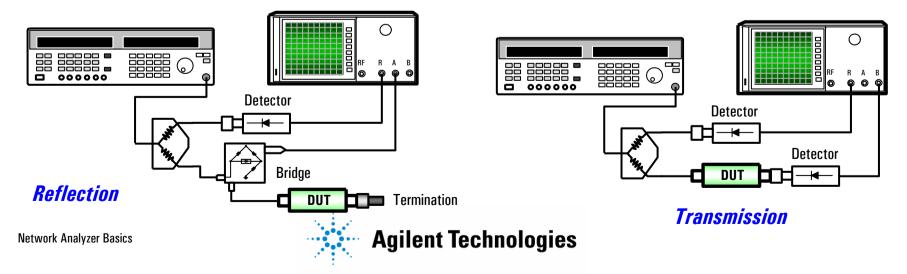
### **Traditional Scalar Analyzer**



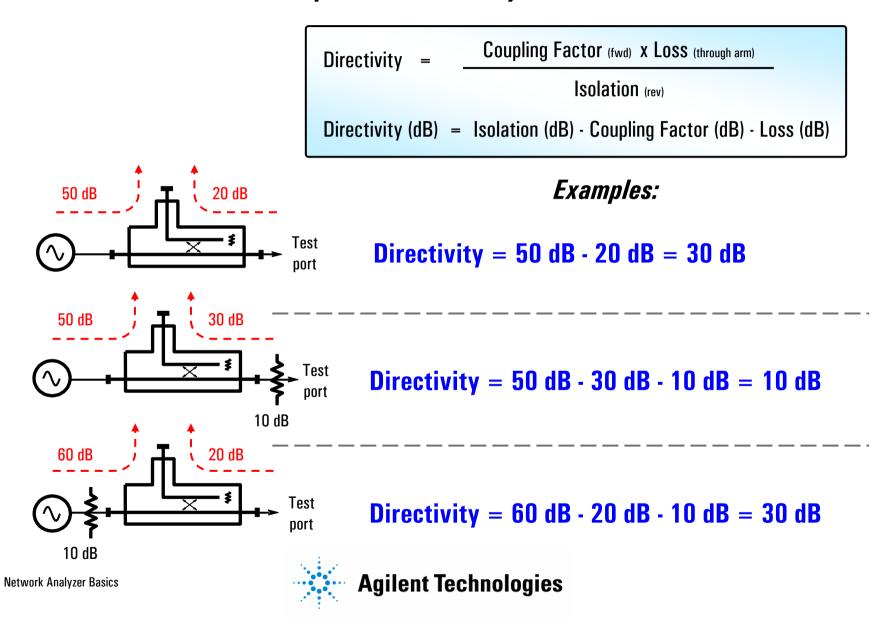


**Example: 8757D** 

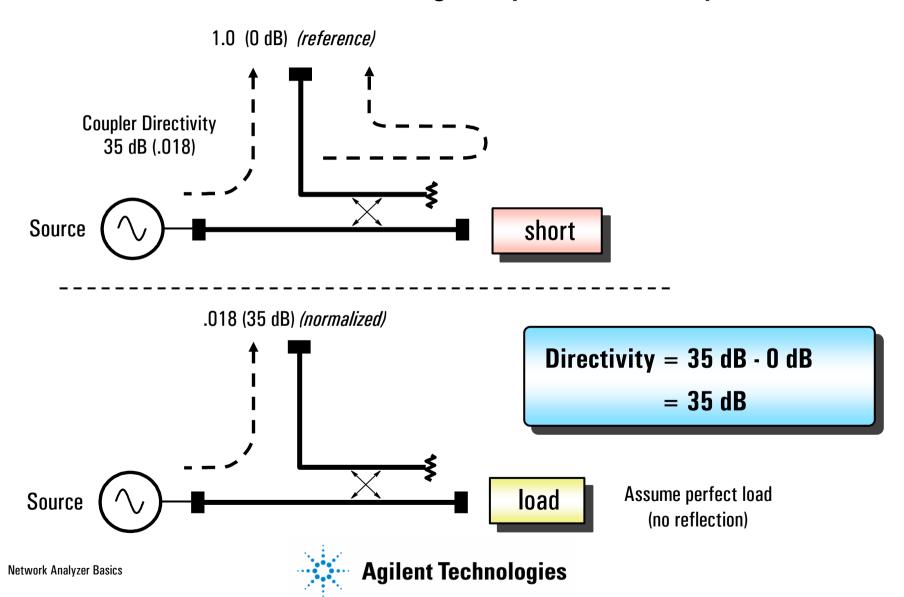
- requires external detectors, couplers, bridges, splitters
- good for low-cost microwave scalar applications



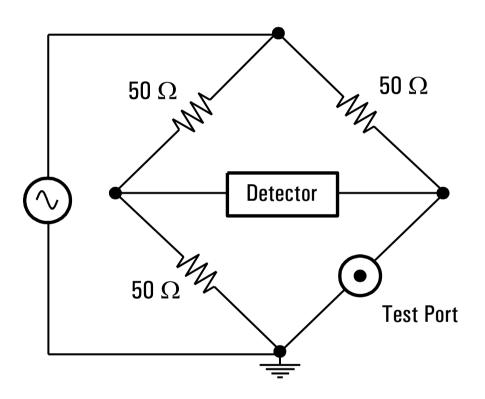
### Directional Coupler *Directivity*



### One Method of Measuring Coupler Directivity



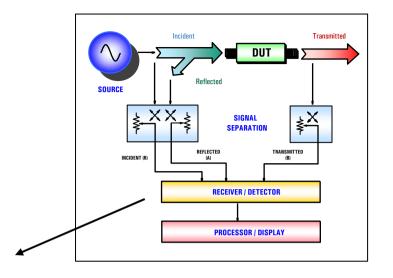
### **Directional Bridge**

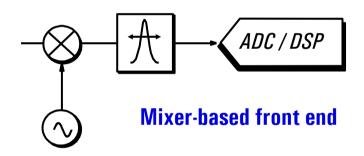


- 50-ohm load at test port balances the bridge -- detector reads zero
- Non-50-ohm load imbalances bridge
- Measuring magnitude and phase of imbalance gives complex impedance
- "Directivity" is difference between maximum and minimum balance

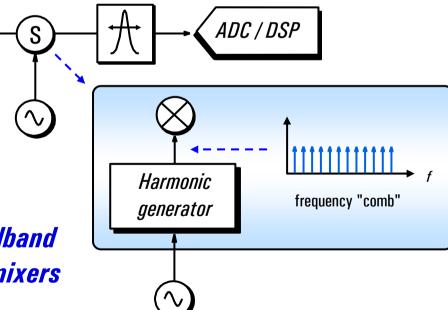


# NA Hardware: Front Ends, Mixers Versus Samplers





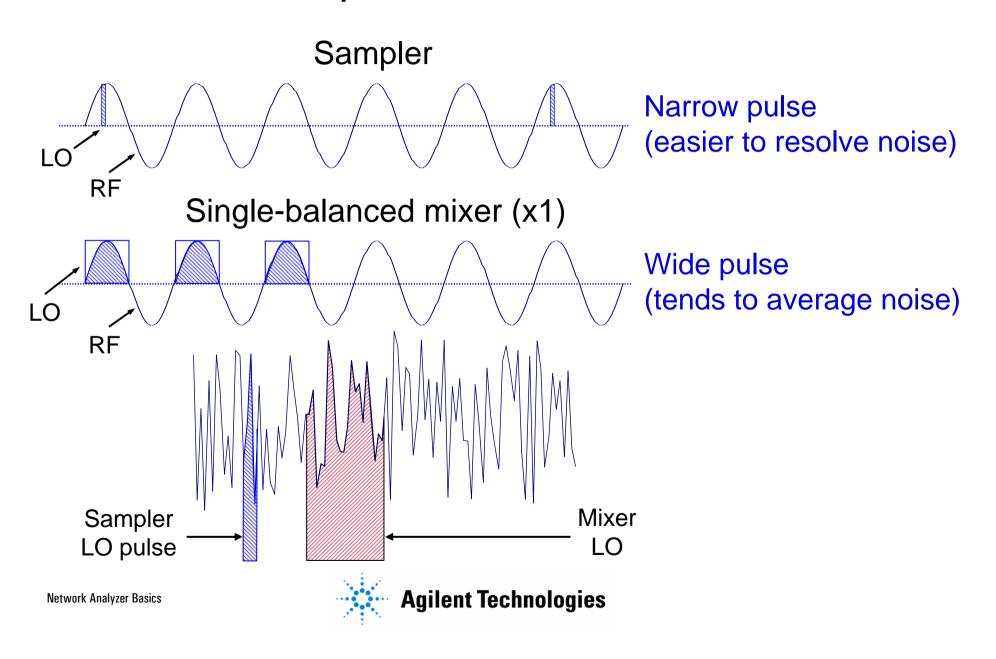
#### Sampler-based front end



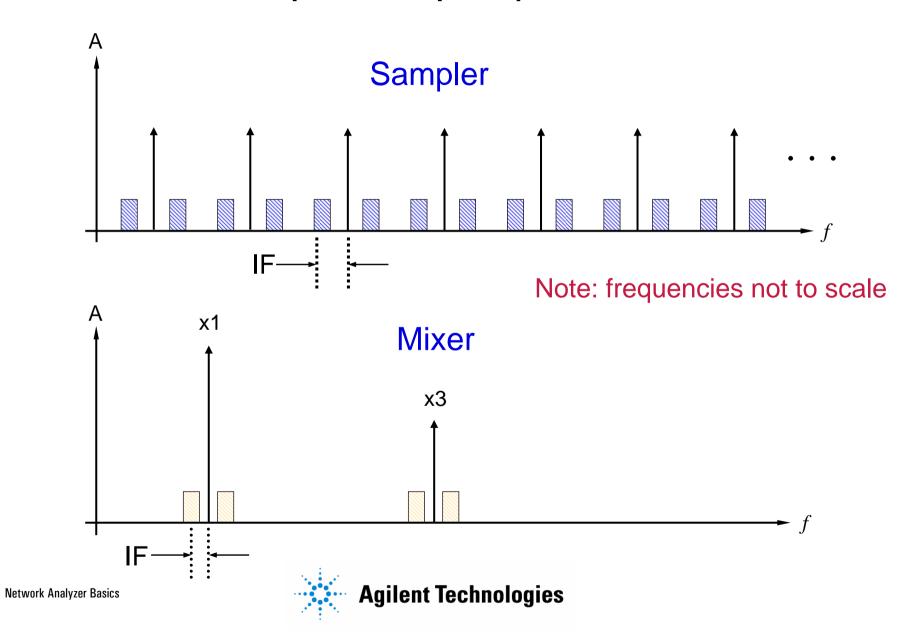
It is cheaper and easier to make broadband front ends using samplers instead of mixers



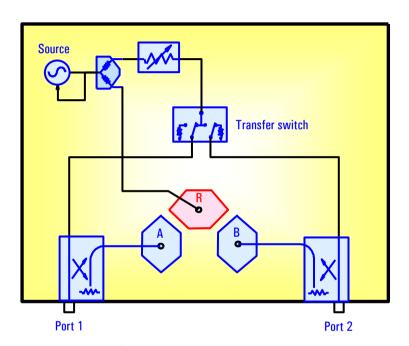
### Mixers Versus Samplers: Time Domain

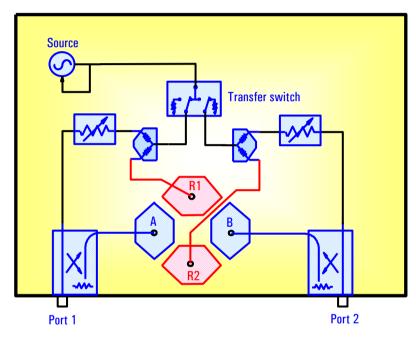


## Mixers Versus Samplers: Frequency Domain



### Three Versus Four-Receiver Analyzers





#### 3 receivers

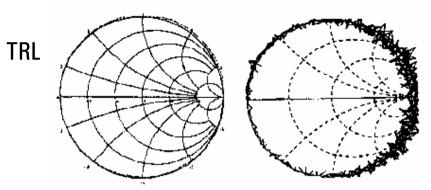
- more economical
- TRL\*, LRM\* cals only
- includes:
  - 8753ES
  - 8720ES (standard)

#### 4 receivers

- more expensive
- true TRL, LRM cals
- includes:
  - PNA Series
  - 8720ES (option 400)
  - 8510C



### Why Are Four Receivers Better Than Three?



TRL\*

- 8720ES Option 400 adds fourth sampler, allowing full TRL calibration
- PNA Series has four receivers standard

- TRL\*
  - assumes the source and load match of a test port are equal (port symmetry between forward and reverse measurements)
  - this is only a fair assumption for three-receiver network analyzers
- TRL
  - four receivers are necessary to make the required measurements
  - TRL and TRL\* use identical calibration standards
- In noncoaxial applications, TRL achieves better source and load match correction than TRL\*
- What about coaxial applications?
  - SOLT is usually the preferred calibration method
  - coaxial TRL can be more accurate than SOLT, but not commonly used



### Challenge Quiz

#### 1. Can filters cause distortion in communications systems?

- A. Yes, due to impairment of phase and magnitude response
- B. Yes, due to nonlinear components such as ferrite inductors
- C. No, only active devices can cause distortion
- D. No, filters only cause linear phase shifts
- E. Both A and B above

#### 2. Which statement about transmission lines is false?

- A. Useful for efficient transmission of RF power
- B. Requires termination in characteristic impedance for low VSWR
- C. Envelope voltage of RF signal is independent of position along line
- D. Used when wavelength of signal is small compared to length of line
- E. Can be realized in a variety of forms such as coaxial, waveguide, microstrip

#### 3. Which statement about narrowband detection is false?

- A. Is generally the cheapest way to detect microwave signals
- B. Provides much greater dynamic range than diode detection
- C. Uses variable-bandwidth IF filters to set analyzer noise floor
- D. Provides rejection of harmonic and spurious signals
- E. Uses mixers or samplers as downconverters



### Challenge Quiz (continued)

#### 4. Maximum dynamic range with narrowband detection is defined as:

- A. Maximum receiver input power minus the stopband of the device under test
- B. Maximum receiver input power minus the receiver's noise floor
- C. Detector 1-dB-compression point minus the harmonic level of the source
- D. Receiver damage level plus the maximum source output power
- E. Maximum source output power minus the receiver's noise floor

#### 5. With a T/R analyzer, the following error terms can be corrected:

- A. Source match, load match, transmission tracking
- B. Load match, reflection tracking, transmission tracking
- C. Source match, reflection tracking, transmission tracking
- D. Directivity, source match, load match
- E. Directivity, reflection tracking, load match

#### 6. Calibration(s) can remove which of the following types of measurement error?

- A. Systematic and drift
- B. Systematic and random
- C. Random and drift
- D. Repeatability and systematic
- E. Repeatability and drift



### Challenge Quiz (continued)

#### 7. Which statement about TRL calibration is false?

- A. Is a type of two-port error correction
- B. Uses easily fabricated and characterized standards
- C. Most commonly used in noncoaxial environments
- D. Is not available on the 8720ES family of microwave network analyzers
- E. Has a special version for three-sampler network analyzers

# 8. For which component is it hardest to get accurate transmission and reflection measurements when using a T/R network analyzer?

- A. Amplifiers because output power causes receiver compression
- B. Cables because load match cannot be corrected
- C. Filter stopbands because of lack of dynamic range
- D. Mixers because of lack of broadband detectors
- E. Attenuators because source match cannot be corrected

#### 9. Power sweeps are good for which measurements?

- A. Gain compression
- B. AM to PM conversion
- C. Saturated output power
- D. Power linearity
- E. All of the above



## Answers to Challenge Quiz

- 1. E
- 2. C
- 3. A
- 4. B
- 5. C
- 6. A
- 7. D
- 8. B
- 9. E

